



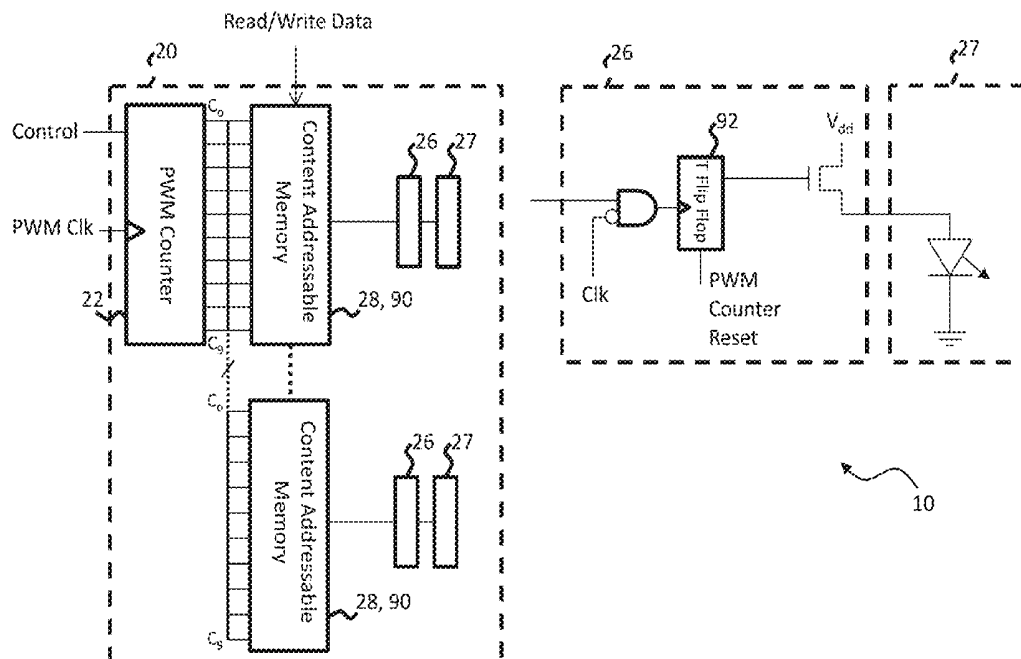
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(19) **United States**(12) **Patent Application Publication**  
**Cok et al.**(10) **Pub. No.: US 2017/0330509 A1**(43) **Pub. Date: Nov. 16, 2017**(54) **MULTI-PIXEL DISTRIBUTED PULSE WIDTH  
MODULATION CONTROL**(71) Applicant: **X-Celeprint Limited**, Cork (IE)(72) Inventors: **Ronald S. Cok**, Rochester, NY (US);  
**Robert R. Rotzoll**, Colorado Springs,  
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*2300/0857* (2013.01); *G09G 2310/0286*  
(2013.01); *G09G 2310/061* (2013.01)

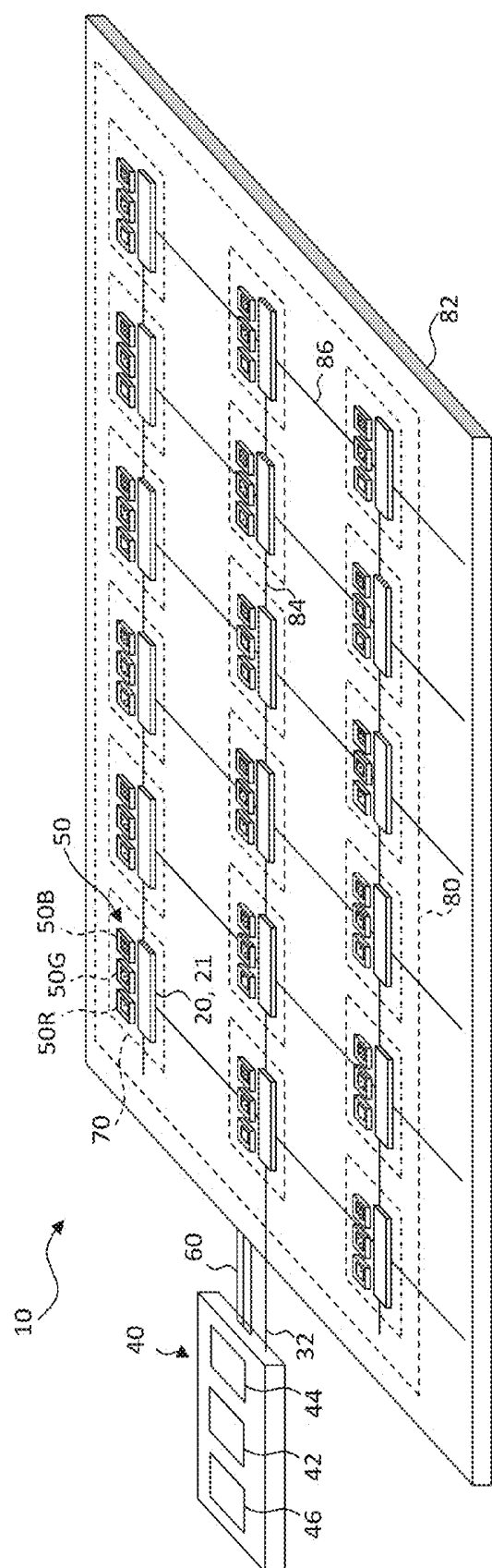
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**ABSTRACT**

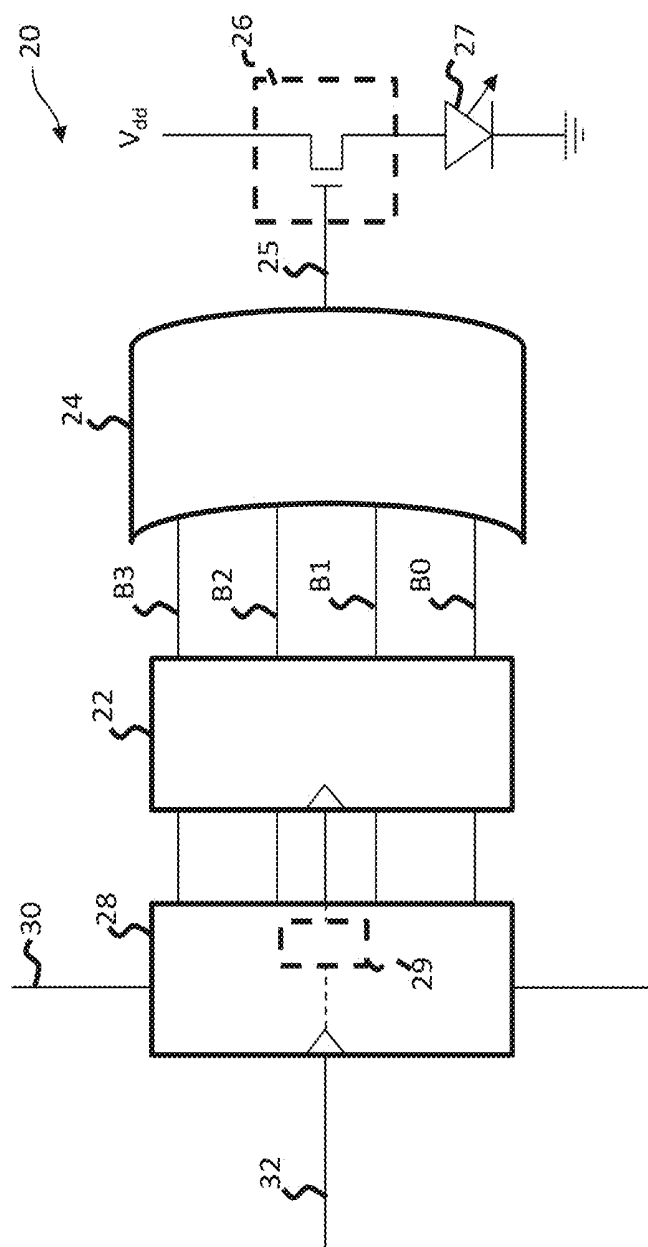
A distributed pulse-width modulation system includes an array of pulse-width modulation elements, each element including a digital memory for storing a plurality of multi-bit digital values, a drive circuit for each stored multi-bit digital value, and an output device for each stored multi-bit digital value. The multi-bit digital values all have the same number of bits. For each stored multi-bit digital value, the corresponding drive circuit drives the corresponding output device in response to the multi-bit digital value stored in the digital memory. A system controller includes a memory for storing the multi-bit digital values for each pulse-width modulation element and a communication circuit communicates each multi-bit digital value to each corresponding pulse-width modulation element.



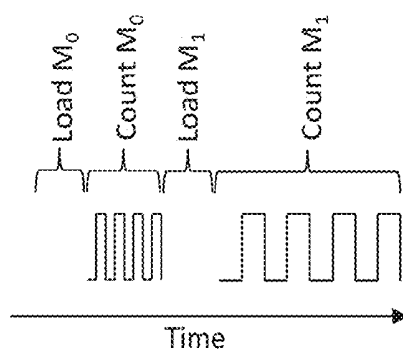
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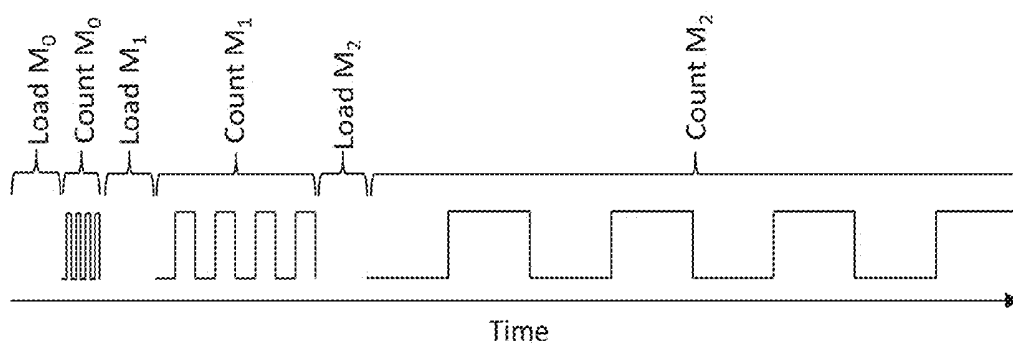
**FIG. 1**



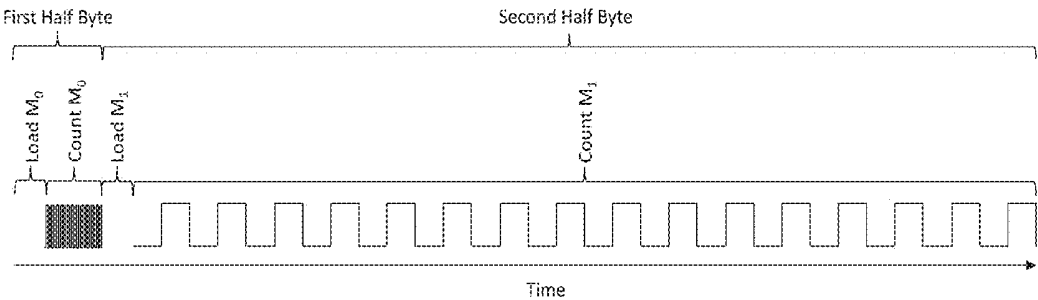
**FIG. 2**



**FIG. 3**



**FIG. 4**



**FIG. 5**

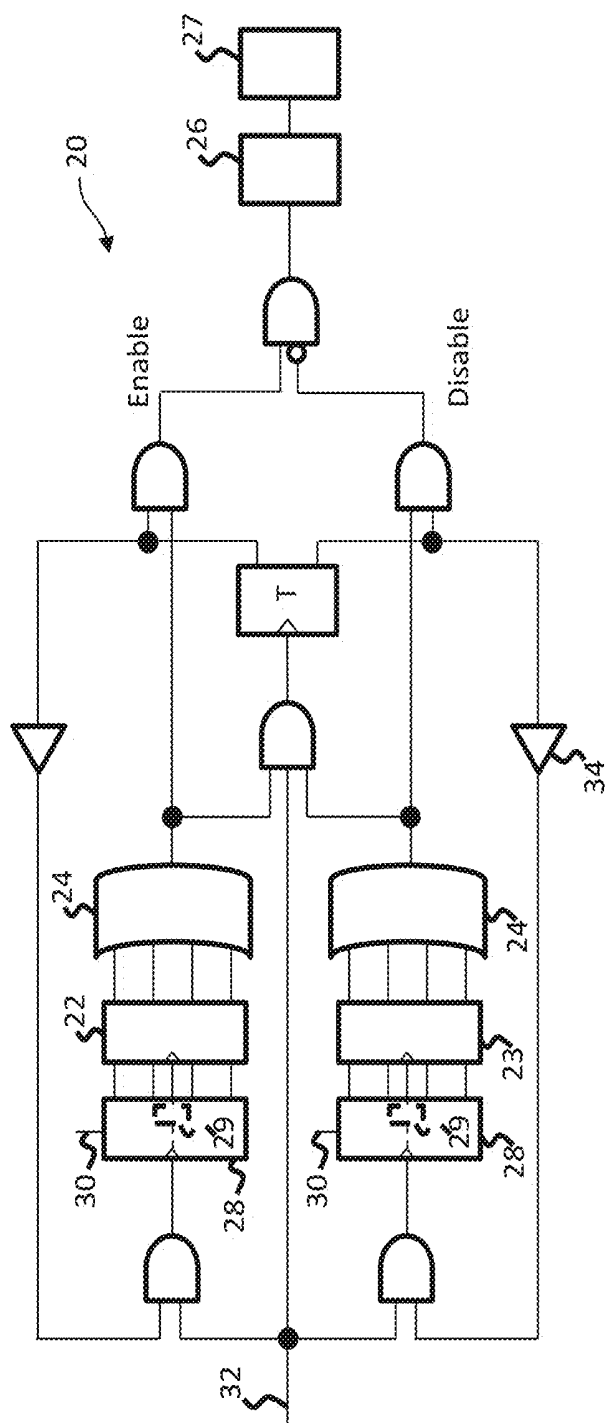
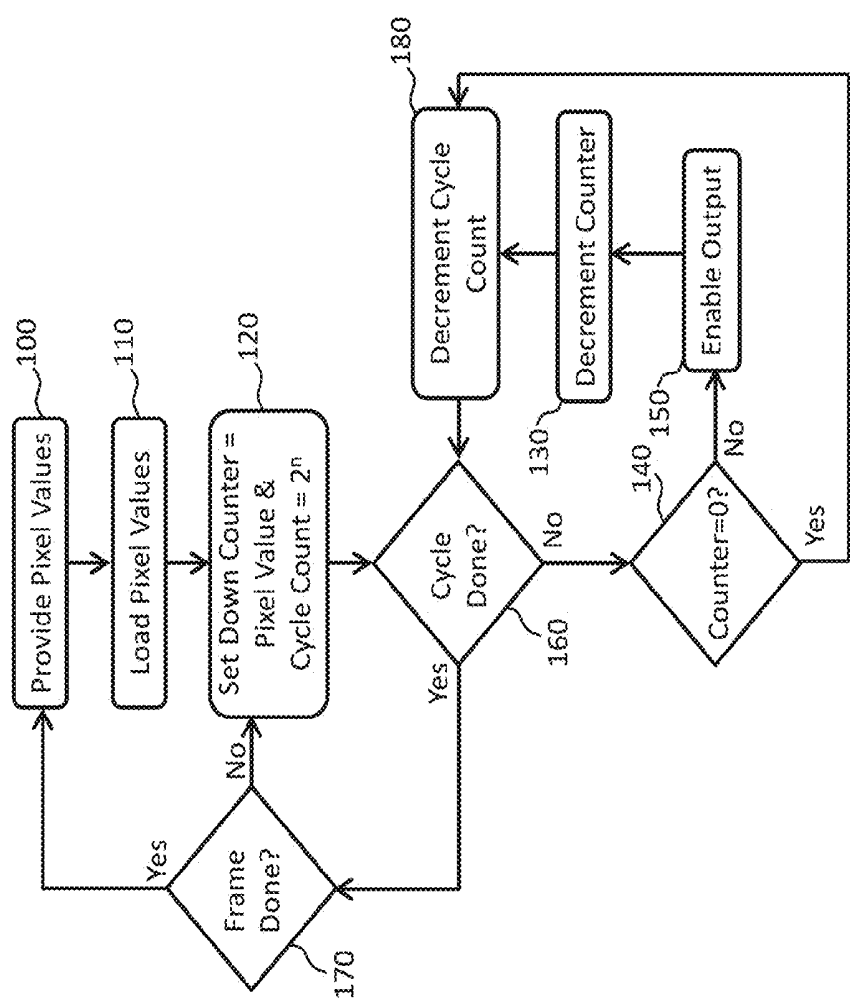
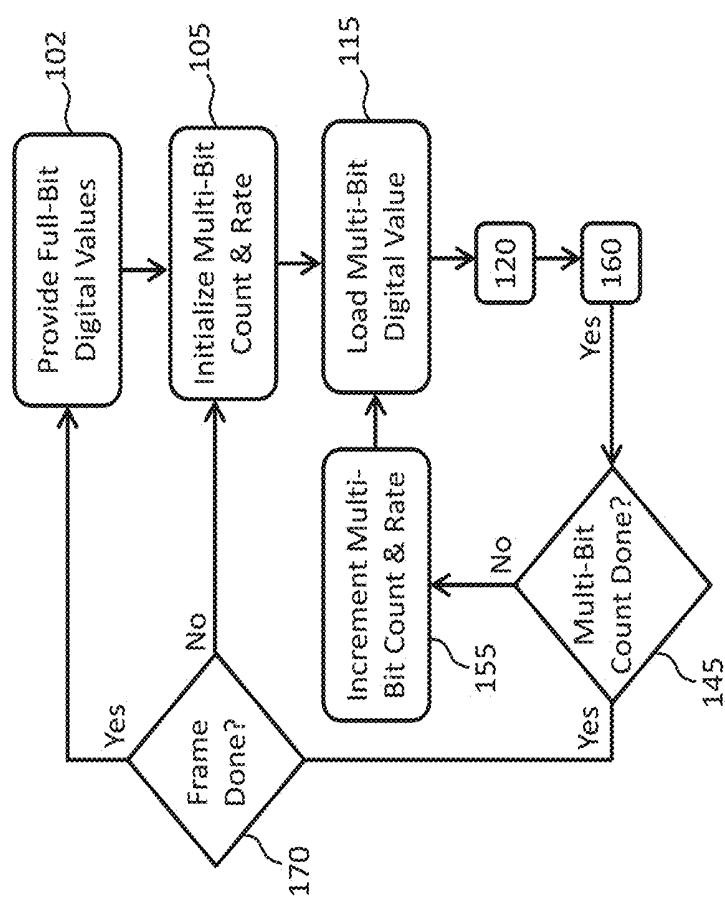


FIG. 6



**FIG. 7**



**FIG. 8**



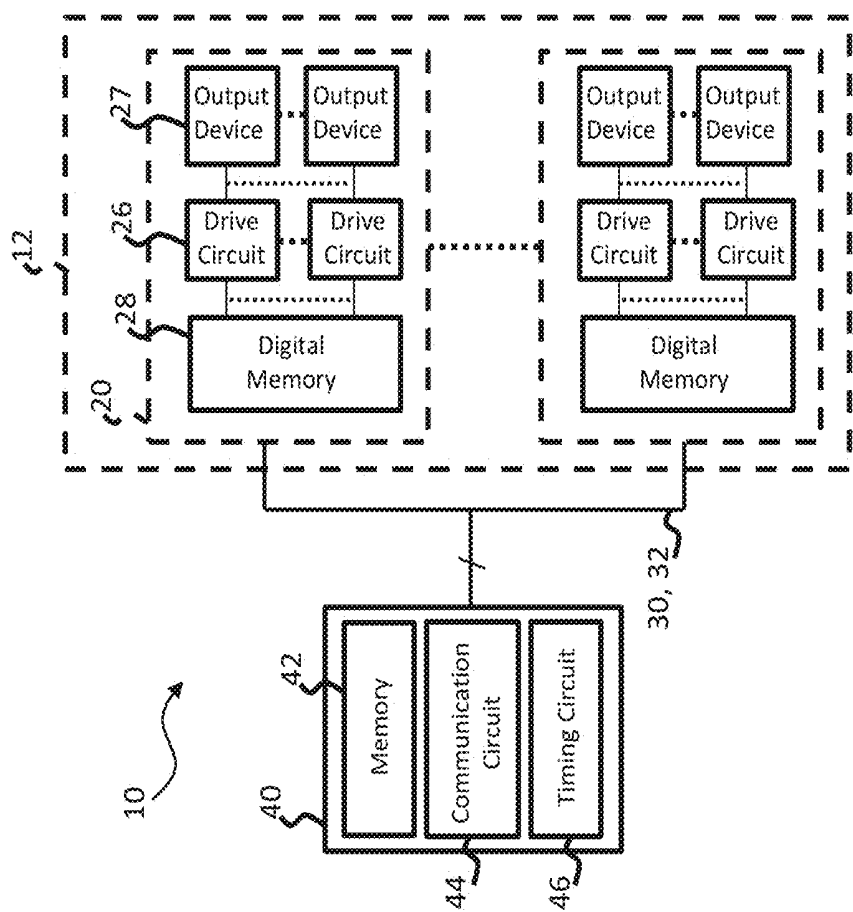


FIG. 9

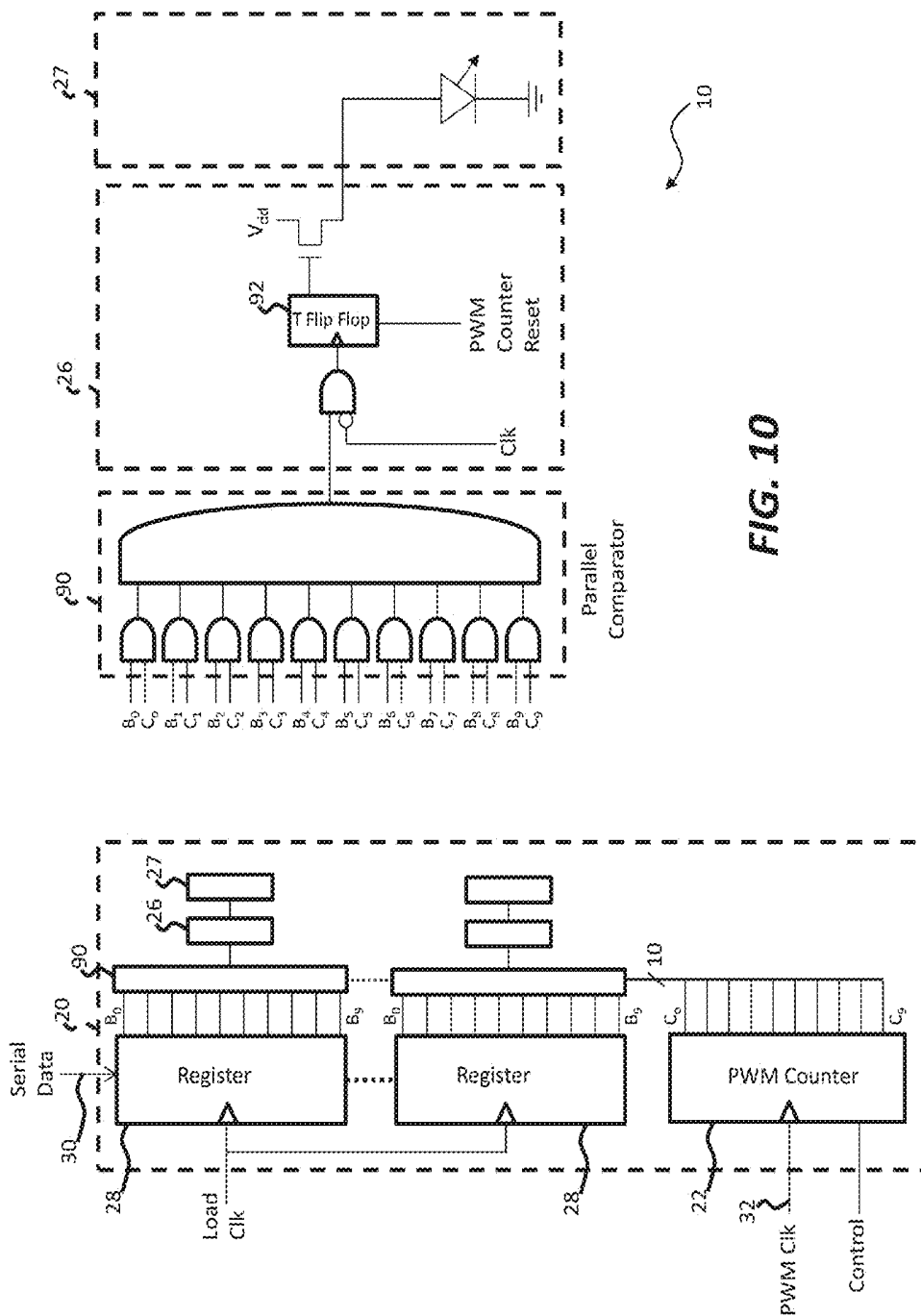


FIG. 10

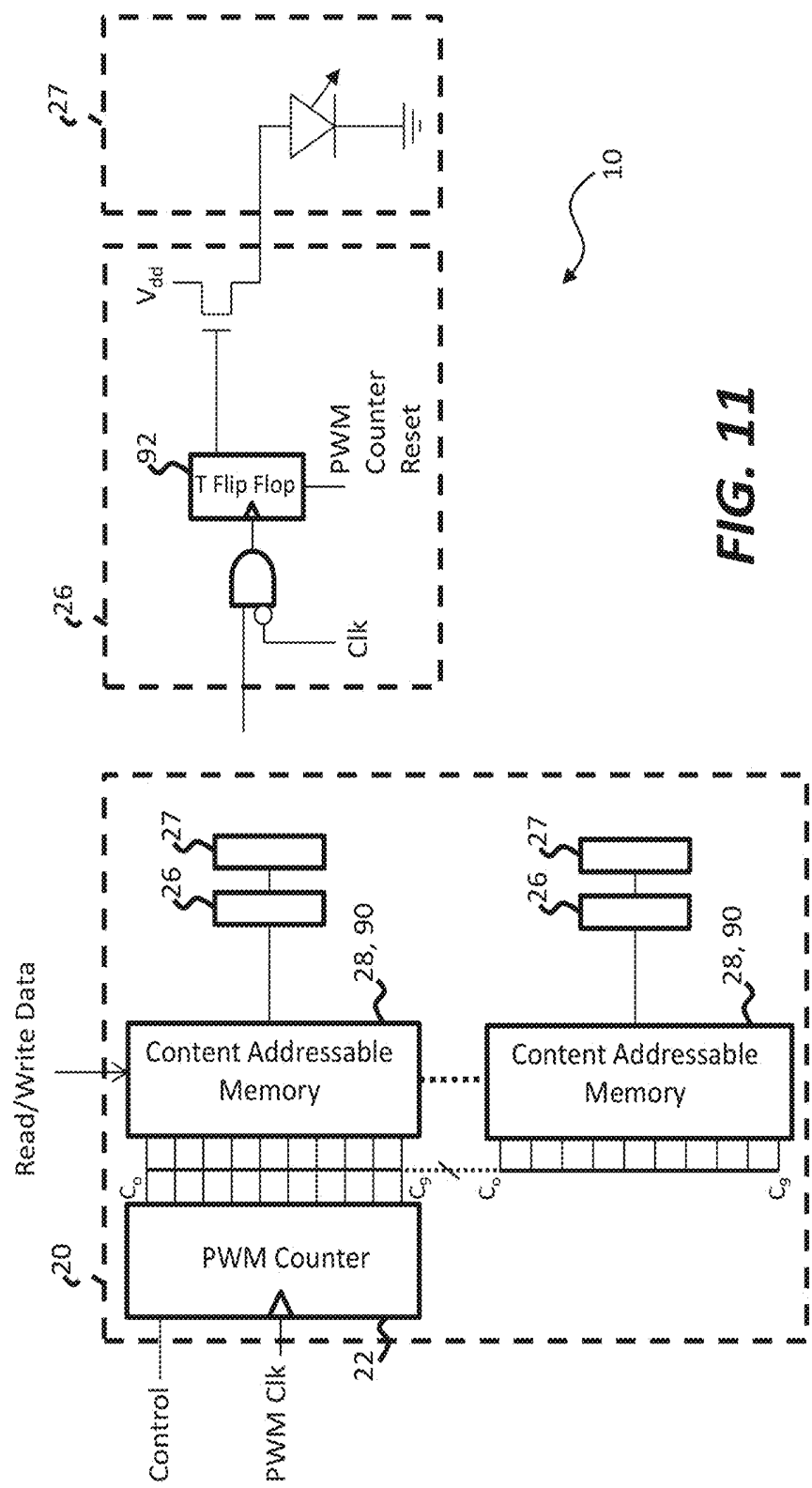


FIG. 11

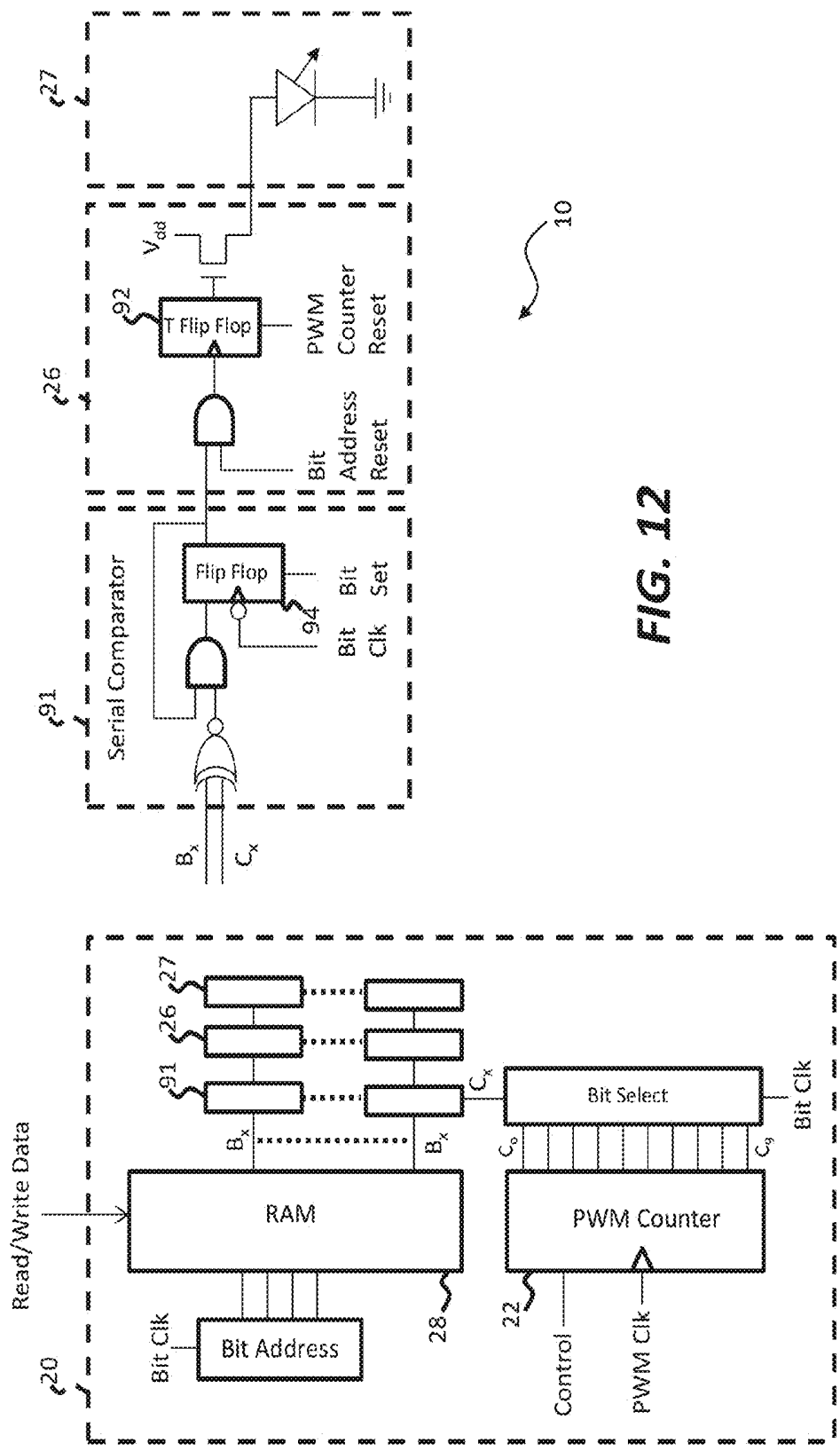


FIG. 12

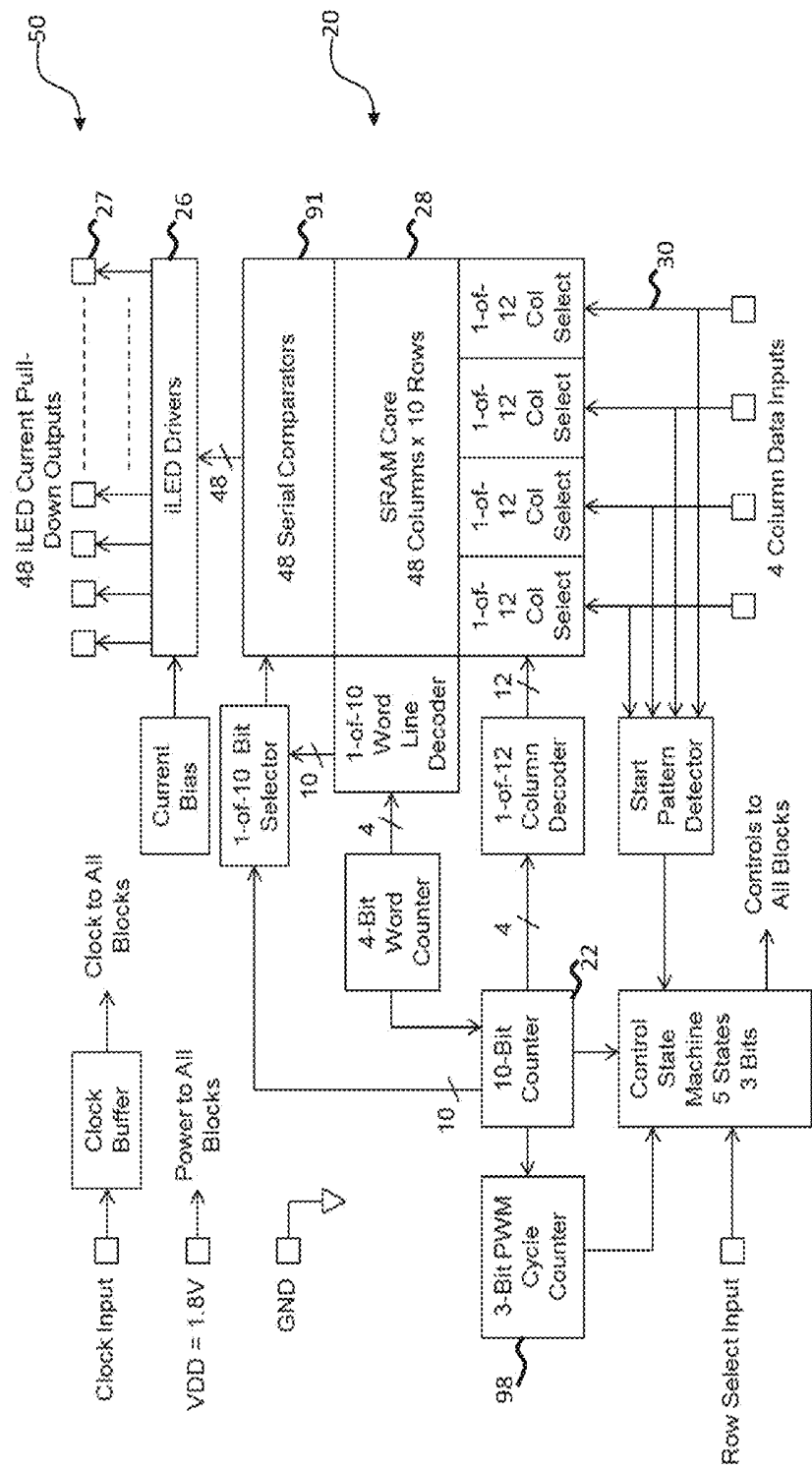


FIG. 13

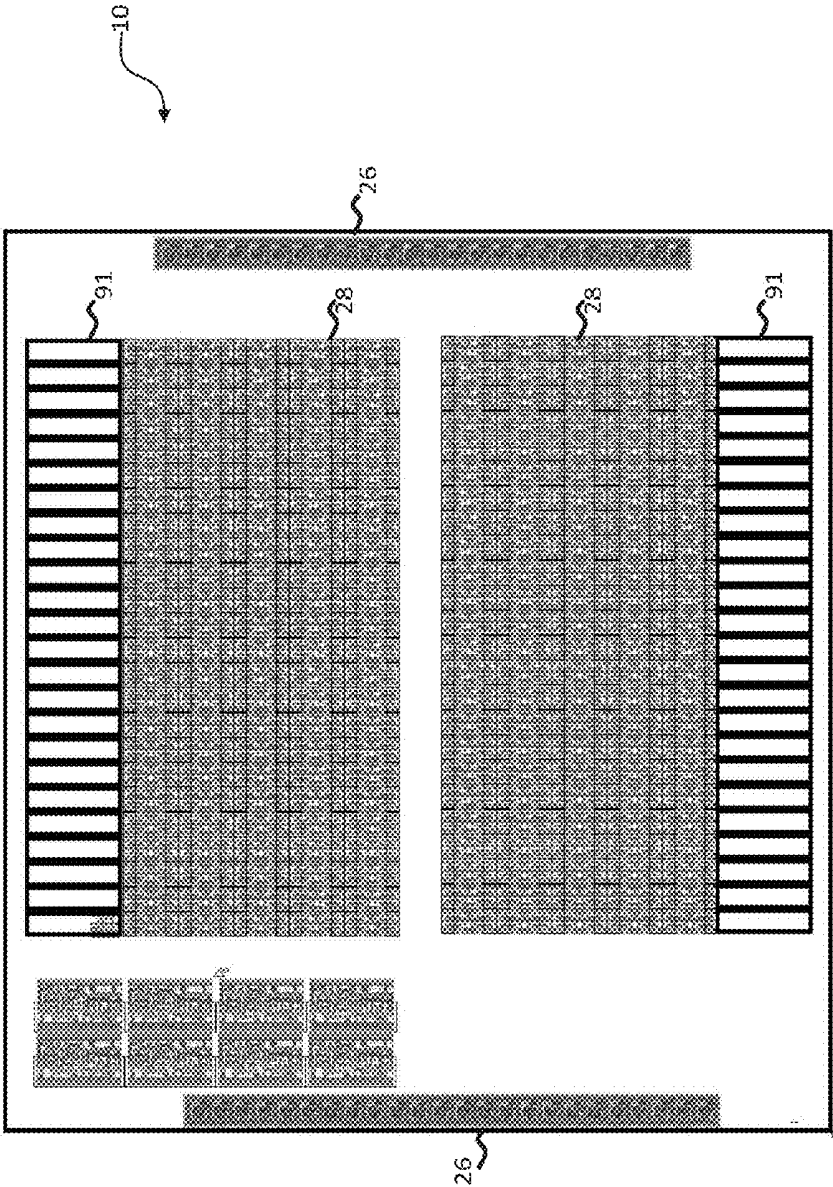
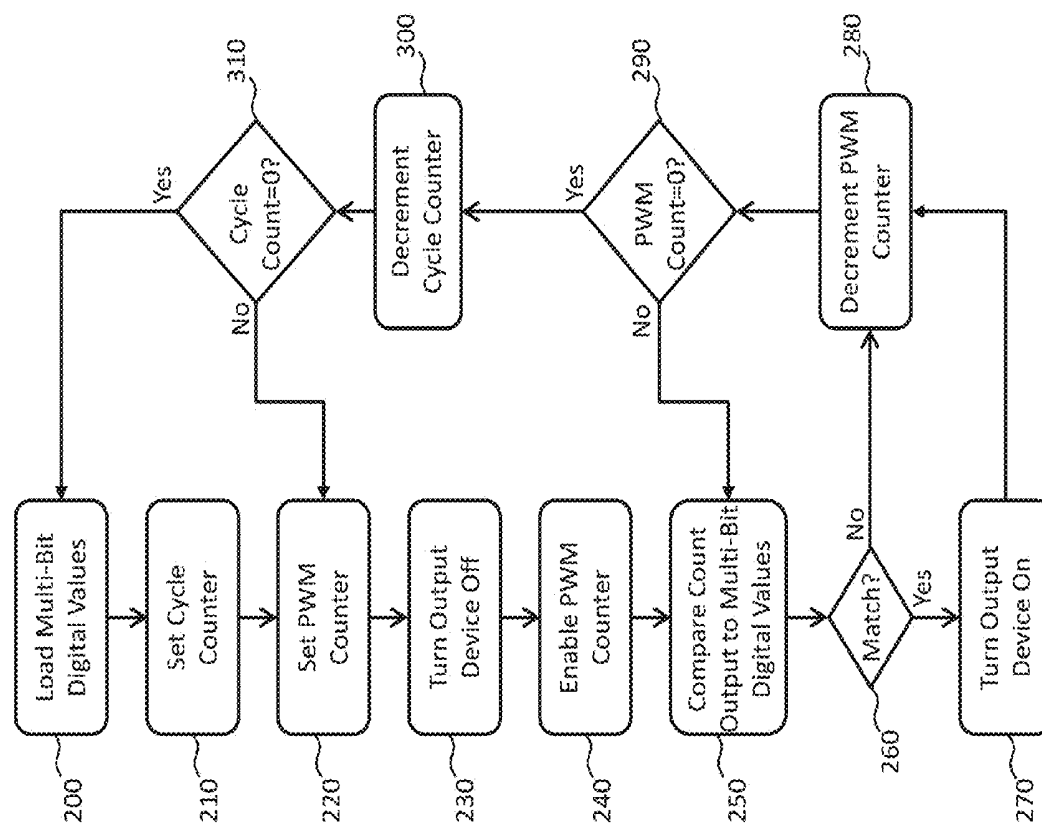
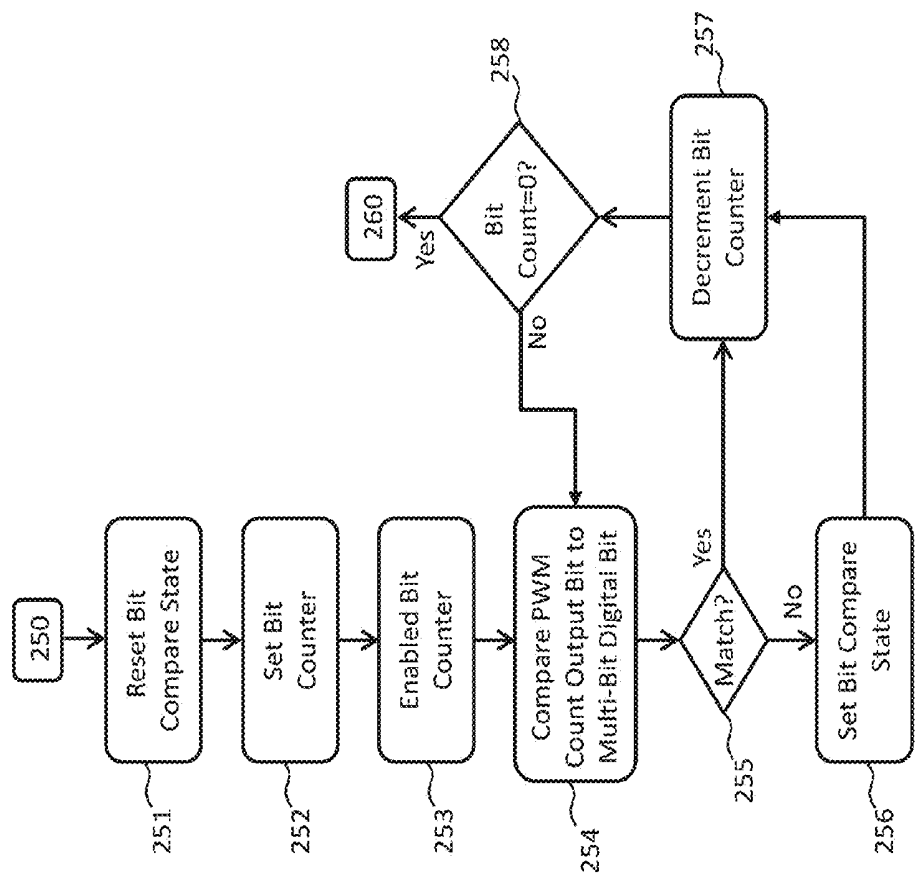


FIG. 14

FIG. 15





**FIG. 16**



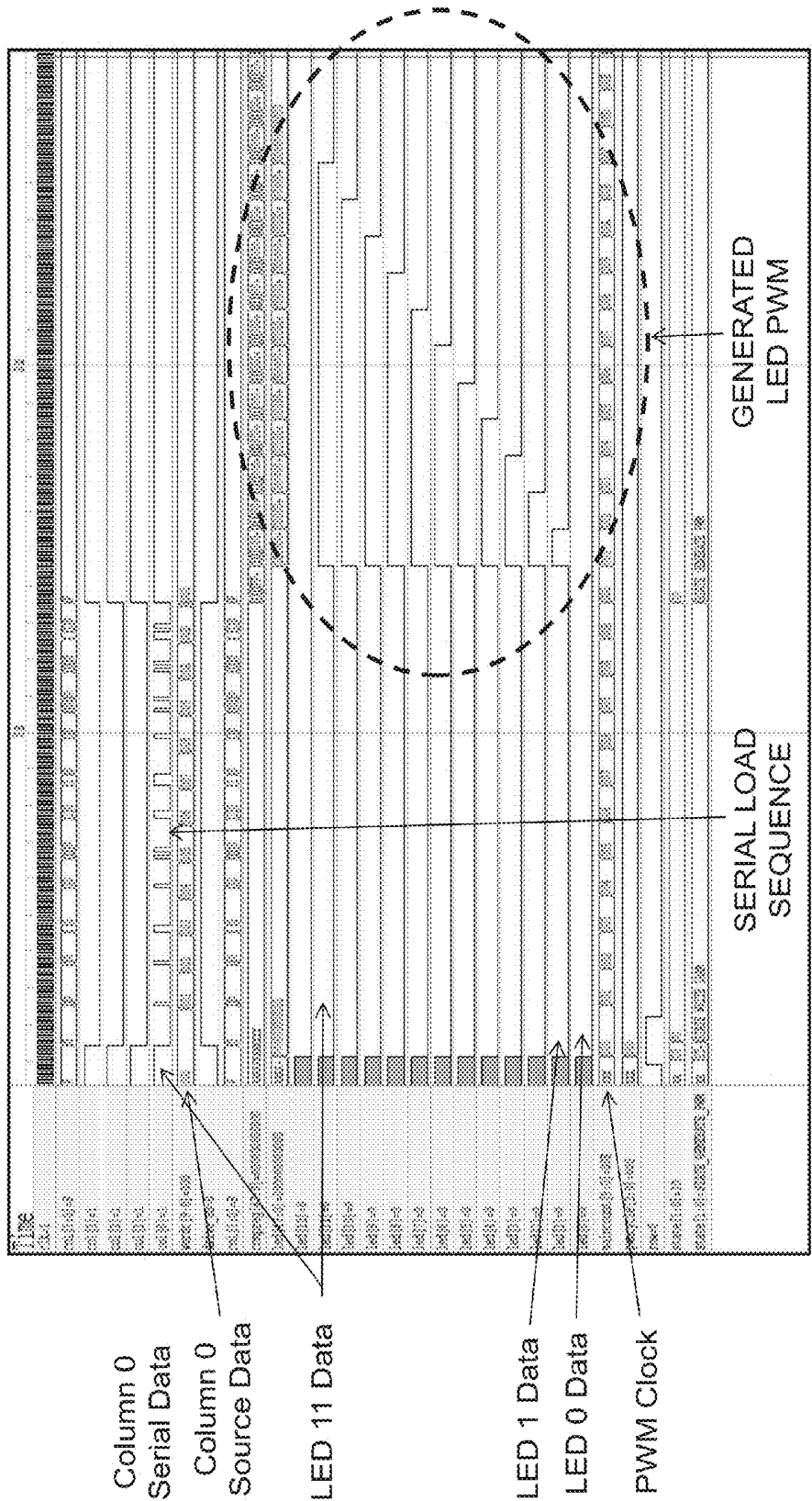


FIG. 17

## MULTI-PIXEL DISTRIBUTED PULSE WIDTH MODULATION CONTROL

### PRIORITY APPLICATION

[0001] This application claims priority to and benefit of U.S. Patent Application No. 62/334,351, filed May 10, 2016, entitled Multi-Pixel Distributed Pulse Width Modulation Control, the content of which is hereby incorporated by reference in its entirety.

### CROSS REFERENCE TO RELATED APPLICATIONS

[0002] Reference is made to commonly assigned U.S. patent application Ser. No. 14/835,282, filed Aug. 25, 2015, entitled Bit-Plane Pulse Width Modulated Digital Display System by Cok et al., the disclosure of which is incorporated herein by reference in its entirety.

### FIELD OF THE INVENTION

[0003] The present invention relates to systems using digital values driven by pulse-width modulation.

### BACKGROUND OF THE INVENTION

[0004] Flat-panel displays are widely used in conjunction with computing devices, in portable devices, and for entertainment devices such as televisions. Such displays typically employ a plurality of pixels distributed over a display substrate to display images, graphics, or text. In a color display, each pixel includes light emitters that emit light of different colors, such as red, green, and blue. For example, liquid crystal displays (LCDs) employ liquid crystals to block or transmit light from a backlight behind the liquid crystals and organic light-emitting diode (OLED) displays rely on passing current through a layer of organic material that glows in response to the current. Displays using inorganic light emitting diodes (LEDs) are also in widespread use for outdoor signage and have been demonstrated in a 55-inch television.

[0005] Displays are typically controlled with either a passive-matrix (PM) control employing electronic circuitry external to the display substrate or an active-matrix (AM) control employing electronic circuitry formed directly on the display substrate and associated with each light-emitting element. Both OLED displays and LCDs using passive-matrix control and active-matrix control are available. An example of such an AM OLED display device is disclosed in U.S. Pat. No. 5,550,066.

[0006] Active-matrix circuits are commonly constructed with thin-film transistors (TFTs) in a semiconductor layer formed over a display substrate and employing a separate TFT circuit to control each light-emitting pixel in the display. The semiconductor layer is typically amorphous silicon or poly-crystalline silicon and is distributed over the entire flat-panel display substrate. The semiconductor layer is photolithographically processed to form electronic control elements, such as transistors and capacitors. Additional layers, for example insulating dielectric layers and conductive metal layers are provided, often by evaporation or sputtering, and photolithographically patterned to form electrical interconnections, or wires.

[0007] Typically, each display sub-pixel is controlled by one control element, and each control element includes at least one transistor. For example, in a simple active-matrix

organic light-emitting diode (OLED) display, each control element includes two transistors (a select transistor and a power transistor) and one capacitor for storing a charge specifying the luminance of the sub-pixel. Each OLED element employs an independent control electrode connected to the power transistor and a common electrode. In contrast, an LCD typically uses a single transistor to control each pixel. Control of the light-emitting elements is usually provided through a data signal line, a select signal line, a power connection and a ground connection. Active-matrix elements are not necessarily limited to displays and can be distributed over a substrate and employed in other applications requiring spatially distributed control.

[0008] Liquid crystals are readily controlled by a voltage applied to the single control transistor. In contrast, the light output from both organic and inorganic LEDs is a function of the current that passes through the LEDs. The light output by an LED is generally linear in response to current but is very non-linear in response to voltage. Thus, in order to provide a well-controlled LED, it is preferred to use a current-controlled circuit to drive each of the individual LEDs in a display. Furthermore, inorganic LEDs typically have variable efficiency at different current, voltage, or luminance levels. It is therefore more efficient to drive the inorganic LED with a particular desired constant current.

[0009] Pulse width modulation (PWM) schemes control luminance by varying the time during which a constant current is supplied to a light emitter. A fast response to a pulse is desirable to control the current and provide good temporal resolution for the light emitter. However, capacitance and inductance inherent in circuitry on a light-emitter substrate can reduce the frequency with which pulses can be applied to a light emitter. This problem is sometimes addressed by using pre-charge current pulses on the leading edge of the driving waveform and a discharge pulse on the trailing edge of the waveform. However, this increases power consumption in the system and can, for example, consume approximately half of the total power for controlling the light emitters.

[0010] Pulse-width modulation is used to provide dimming for light-emissive devices such as back-light units in liquid crystal displays. For example, U.S. Patent Publication No. 2008/0180381 describes a display apparatus with a PWM dimming control function in which the brightness of groups of LEDs in a backlight are controlled to provide local dimming and thereby improve the contrast of the LCD.

[0011] OLED displays are also known to include PWM control, for example as taught in U.S. Patent Publication No. 2011/0084993. In this design, a storage capacitor is used to store the data value desired for display at the pixel. A variable-length control signal for controlling a drive transistor with a constant current is formed by a difference between the analog data value and a triangular wave form. However, this design requires a large circuit and six control signals, limiting the display resolution for a thin-film transistor backplane.

[0012] U.S. Pat. No. 7,738,001 describes a passive-matrix control method for OLED displays. By comparing a data value to a counter in a row or column driver, a binary control signal indicates when the pixel in the corresponding row or column should be turned on. This approach requires a counter and comparison circuit for each pixel in a row or column and is only feasible for passive-matrix displays. U.S.

Pat. No. 5,731,802 describes a passive-matrix control method for displays. However, large passive-matrix displays can suffer from flicker.

**[0013]** U.S. Pat. No. 5,912,712 discloses a method for expanding a pulse width modulation sequence to adapt to varying video frame times by controlling a clock signal. This design does not use pulse width modulation for controlling a display pixel.

**[0014]** There remains a need, therefore, for active-matrix display systems that provide efficient, constant current drive signals to light emitters and have high resolutions.

#### SUMMARY OF THE INVENTION

**[0015]** The present invention includes, among various embodiments, a system incorporating a plurality of distributed elements, each incorporating a multi-bit pulse-width modulation circuit for independently providing multi-bit pulse-width modulation control to each element. In some embodiments, the system is a digital-drive display system or, more succinctly, a digital display. An array of elements such as display pixels is arranged, for example on a display substrate. Each element includes an output device, such as a light emitter, a digital memory for storing a multi-bit digital value, such as a pixel value, and a drive circuit that drives the output device in response to the multi-bit digital value. The drive circuit can provide a voltage or a current in response to the value of the multi-bit digital value. The drive circuit can provide a constant current source that is supplied to the output device for a time period corresponding to the multi-bit digital value.

**[0016]** Constant current sources are useful for driving light-emitting diodes (LEDs) because LEDs are typically most efficient within a limited range of currents so that a temporally varied constant current drive is more efficient than a variable current drive or variable voltage drive. However, conventional schemes for providing temporal control, for example pulse width modulation (PWM), are generally employed in passive-matrix displays which suffer from flicker and are therefore limited to relatively small displays. A prior-art constant-current drive used in an OLED active-matrix display requires analog storage and complex control schemes with relatively large circuits and many control signals to provide a temporal control, limiting the density of pixels on a display substrate.

**[0017]** The present invention at least partially addresses these limitations by providing digital storage for a multi-bit digital value at each element location. Digital storage is not practical for conventional flat-panel displays that use thin-film transistors because the thin-film circuits required for digital pixel value storage are much too large to achieve desirable display resolution. However, according to the present invention, small micro transfer printed integrated circuits (chips) having a crystalline semiconductor substrate can provide small, high-performance digital pixel value storage circuits and temporally controlled constant-current LED drive circuits in a digital display with practical resolution. Such a display has excellent resolution because the chips are very small, has excellent efficiency by using constant-current drive for LEDs, and has reduced flicker by using a high-frequency active-matrix control structure.

**[0018]** In further embodiments of the present invention, display pixels are repeatedly loaded with different multi-bit digital values making up a full-bit digital value to provide arbitrary bit depth and gray-scale resolution. Control signals

provided by a system controller enables output devices, such as micro-light-emitting diodes, in each element for a period corresponding to the multi-bit digital values loaded into the array of elements.

**[0019]** In some embodiments of the present invention, a distributed pulse-width modulation system comprises:

**[0020]** an array of pulse-width modulation elements, each element including a digital memory for storing a multi-bit digital value and a drive circuit that drives an output device in response to the multi-bit digital value stored in the digital memory;

**[0021]** a system controller including a memory for storing a multi-bit digital value for each element and a communication circuit for communicating each multi-bit digital value to each corresponding pulse-width modulation element.

**[0022]** In some embodiments, the present invention is a distributed pulse-width modulation system because pulse-width modulation elements in the array are spatially distributed over a substrate and each provided an independent pulse-width modulation control to the output device in the element. Each element can store a different multi-bit digital value and each output device in the element in the array can independently output the different multi-bit digital value, so that each element has a different output.

**[0023]** In other embodiments, a pixel circuit for a digital display system comprises a digital memory for storing a multi-bit digital value and a drive circuit that drives a light emitter in response to the multi-bit digital value stored in the digital memory.

**[0024]** In yet further embodiments, a method of controlling a distributed pulse-width modulation system comprises:

**[0025]** providing an array of multi-bit digital values;

**[0026]** loading each element of the array of elements with a multi-bit digital value of the array of multi-bit digital values;

**[0027]** providing a timing signal to each element;

**[0028]** combining the timing signal and the multi-bit digital value to provide a temporally controlled signal in each element, the temporally controlled signal responsive to the value of the multi-bit digital value; and

**[0029]** driving the output device of each element in response to the temporally controlled signal.

**[0030]** In one aspect, the disclosed technology includes a distributed pulse-width modulation system, including: an array of pulse-width modulation elements, each element including a digital memory for storing a plurality of multi-bit digital values, the multi-bit digital values all having the same number of bits; a drive circuit for each stored multi-bit digital value; and an output device for each stored multi-bit digital value, wherein for each stored multi-bit digital value, the corresponding drive circuit driving the corresponding output device in response to the multi-bit digital value stored in the digital memory; and a system controller including a memory for storing the multi-bit digital values for each pulse-width modulation element and a communication circuit for communicating each multi-bit digital value to each corresponding pulse-width modulation element.

**[0031]** In certain embodiments, the system controller includes a timing circuit for providing timing signals to each element and wherein the timing signals control the rate at which the output devices are driven in response to the multi-bit digital values stored in the digital memory.

**[0032]** In certain embodiments, each element comprises a PWM counter with a counter output having as many bits as

the number of bits in the multi-bit digital values and a comparator circuit for each stored multi-bit digital value, wherein each comparator circuit compares the counter output to the corresponding multi-bit digital value, and wherein each drive circuit is responsive to the output of the corresponding comparator circuit.

[0033] In certain embodiments, the comparator circuit is a parallel comparator circuit.

[0034] In certain embodiments, the comparator circuit is a serial comparator circuit.

[0035] In certain embodiments, the drive circuit comprises an output state indicating whether the output is off or on and the drive circuit drives the output device to output a signal when the output state is on and drives the output device such that the output device does not output a signal when the output state is off.

[0036] In certain embodiments, the drive circuit drives the output device to output a signal in a constant state over time when the output state is on.

[0037] In certain embodiments, the signal is an electrical signal and the constant state is a constant current or a constant voltage, or both.

[0038] In certain embodiments, the system includes a cycle counter and wherein the cycle counter is separate from the PWM counter or wherein the cycle counter and the PWM counter are part of a common counter, the PWM counter operating with the cycle counter to provide multiple cycles of PWM timing signals for the multi-bit digital values.

[0039] In certain embodiments, the drive circuit comprises an output state indicating whether the output is off or on and wherein the drive circuit includes circuitry to set the output state to the off state when the lower counter bits are equal to zero.

[0040] In certain embodiments, the comparator circuit includes an exclusive NOR combination of at least a portion of the bits of the counter value and the bits of the corresponding multi-bit digital value.

[0041] In certain embodiments, the digital memory is a register, a random access memory, or a content addressable memory.

[0042] In certain embodiments, the output device is a light emitter, a light-emitting diode, an inorganic light-emitting diode, or a micro-light-emitting diode.

[0043] In another aspect, the disclosed technology includes a method of operating the distributed pulse-width modulation system as described in an exemplary embodiment above, the method including: loading the multi-bit digital values into the digital memory of each element; and driving each output device in response to the corresponding multi-bit digital value.

[0044] In another aspect, the disclosed technology includes a method of operating the distributed pulse-width modulation system of an exemplary embodiment above, the method including: loading the multi-bit digital values into each element; setting the PWM counter to an initial count value; and repeatedly operating the PWM counter to count and comparing the PWM counter output to each multi-bit digital value with the comparator circuit and, if the PWM counter output matches the multi-bit digital value, driving each output device with the drive circuit to output a signal or to stop outputting a signal.

[0045] In certain embodiments, the element includes a cycle counter and comprising restarting the PWM counter

each time the cycle counter counts and restarting the cycle counter responsive to the communication circuit.

[0046] In certain embodiments, the drive circuit includes an output state indicating whether the output is off or on.

[0047] In certain embodiments, the method includes setting the output state to the off state responsive to the PWM counter output equaling zero or starting a count cycle.

[0048] In certain embodiments, the method includes setting the output state to the on state responsive to the PWM counter output equaling zero or starting a count cycle.

[0049] In certain embodiments, the drive circuit comprises an output state indicating whether the output is off or on.

[0050] In certain embodiments, the method includes setting the output state to the on state responsive to the PWM counter bits equaling the stored multi-bit digital value.

[0051] In certain embodiments, the method includes setting the output state to the off state responsive to the PWM counter bits equaling the stored multi-bit digital value.

[0052] In certain embodiments, each comparator circuit is a parallel comparator circuit and the digital memory includes registers having parallel register outputs, and comprising simultaneously comparing each bit of the multi-bit digital value in the corresponding register to the corresponding bit of the PWM counter output with the corresponding parallel comparator circuit and driving each output device, with the corresponding drive circuit, to output a signal in response to a match between the corresponding multi-bit digital value and the PWM counter output.

[0053] In certain embodiments, each comparator circuit is a serial comparator circuit and the digital memory is a random access memory storing the bits of each multi-bit digital value at a common address in corresponding bit planes, and comprising sequentially comparing each bit of the multi-bit digital values to the corresponding bit of the PWM counter output with the corresponding serial comparator circuit and driving each output device, with the corresponding drive circuit, to output a signal in response to a match between the corresponding multi-bit digital value and the PWM counter output.

#### BRIEF DESCRIPTION OF THE DRAWINGS

[0054] The foregoing and other objects, aspects, features, and advantages of the present disclosure will become more apparent and better understood by referring to the following description taken in conjunction with the accompanying drawings, in which:

[0055] FIG. 1 is a schematic perspective of an exemplary embodiment of the present invention;

[0056] FIG. 2 is a schematic diagram of an element of the illustrative embodiment of FIG. 1;

[0057] FIGS. 3-5 are timing diagrams illustrating the operation of various embodiments of the present invention;

[0058] FIG. 6 is a schematic diagram of an alternate element of the illustrative embodiment of FIG. 1;

[0059] FIG. 7 and FIG. 8 are flow diagrams illustrating exemplary methods of the present invention;

[0060] FIG. 9 is a schematic of an exemplary embodiment of the present invention having an array of pulse-width modulation elements;

[0061] FIG. 10 is a schematic of an exemplary embodiment of the present invention having an array of pulse-width modulation elements including registers and parallel comparators;

[0062] FIG. 11 is a schematic of an exemplary embodiment of the present invention having an array of pulse-width modulation elements including content addressable memories;

[0063] FIG. 12 is a schematic of an exemplary embodiment of the present invention having an array of pulse-width modulation elements including random access memory (RAM);

[0064] FIG. 13 is a more detailed schematic of an exemplary embodiment of the present invention having an array of pulse-width modulation elements including random access memory (RAM);

[0065] FIG. 14 is a layout of the embodiment of FIG. 13 in an exemplary embodiment of the present invention;

[0066] FIGS. 15-16 are flow diagrams illustrating methods of the present invention; and

[0067] FIG. 17 is a simulation of an exemplary embodiment of the present invention.

[0068] The features and advantages of the present disclosure will become more apparent from the detailed description set forth below when taken in conjunction with the drawings, in which like reference characters identify corresponding elements throughout. In the drawings, like reference numbers generally indicate identical, functionally similar, and/or structurally similar elements. The figures are not drawn to scale since the variation in size of various elements in the Figures is too great to permit depiction to scale.

#### DETAILED DESCRIPTION OF THE INVENTION

[0069] Referring to the perspective illustration of FIG. 1 and the corresponding detailed schematic of FIG. 2, according to an exemplary embodiment of the present invention a distributed pulse-width modulation system 10 includes an array of pulse-width modulation elements 20. In some embodiments, the array of pulse-width modulation elements 20 is spatially distributed over a system substrate 82 in rows and columns. Each element 20 includes a digital memory 28 for storing a multi-bit digital value and a drive circuit 26 that drives an output device 27 in response to the multi-bit digital value stored in the digital memory 28. A system controller 40 includes a memory 42 for storing a multi-bit digital value for each element 20 and a communication circuit 44 for communicating each multi-bit digital value to each corresponding pulse-width modulation element 20, for example through a bus 60 electrically connecting the system controller 40 to the elements 20.

[0070] The system controller 40 can be, for example, an integrated circuit including the memory 42, such as a static or dynamic memory, and the communication circuit 44 can be a logic circuit with output drivers (such as transistors) providing signals on output wires connected, for example, to the bus 60 connected to the system substrate 82 and to row lines 84 and column lines 86 to provide active-matrix-addressed control to the array of elements 20. For example, the electrical connections on the system substrate 82 can be electrically conductive wires. For clarity, the electrical connections between the bus 60 and the row lines 84 and column lines 86 are not shown.

[0071] The element 20 can be, for example, an integrated circuit including the digital memory 28 and the drive circuit 26 can be an analog or digital or mixed-signal circuit with output drivers (such as transistors) controlling the output device 27. The element 20 can be provided in a bare die,

unpackaged integrated circuit, or discrete components and can be mounted on the system substrate 82 using micro-transfer printing.

[0072] The distributed pulse-width modulation system 10 can be a display system, the output device 27 can be a light emitter, for example a light-emitting diode (LED) such as an inorganic micro-light-emitting diode, and the system controller 40 can be a display controller. The elements 20 can be pixels and the multi-bit digital values can be pixel values specifying light output from the LEDs. The elements 20 can form an array of elements 20 arranged in rows and columns on the system substrate 82 to form a display. As illustrated in FIG. 1, three elements 20 are included in a common integrated circuit chiplet 21 (also indicated as a common element 20). Each of the elements 20 in the chiplet 21 includes a different output device 27. Each different output device is an inorganic micro-light emitter that emits a different color of light. In the FIG. 1 embodiment, the output devices 27 are a red light emitter 50R that emits red light, a green light emitter 50G that emits green light, and a blue light emitter 50B that emits blue light. Taken together the light emitters 50 and elements 20 provide a full-color pixel 70. The full-color pixel includes three elements 20 (one for each color of light emitter 50). As used herein, a pixel includes a single output device 27. As shown in FIG. 1, the three elements 20 are provided in a single integrated circuit, for example a small chiplet 21 such as a bare die. In other embodiments, each element 20 can be a separate integrated circuit chiplet 21 or can be provided in discrete components (not shown).

[0073] The system controller 40 provides a multi-bit digital value to each element 20. This can be done in any of a variety of ways. In the embodiment illustrated in FIG. 1, the system controller 40 serially shifts a sequence of multi-bit digital values through each of a series of elements 20 arranged in a row with a common clock signal 32. Multiple rows of elements 20 can be loaded at the same time or at different times. In other embodiments, the elements 20 can be accessed using matrix addressing and the multi-bit digital values can be provided in parallel rather than as a serial bit stream. In such cases, the digital memory 28 can have a parallel data input control rather than the serial input control illustrated in FIG. 2. Other logical designs can be used.

[0074] Referring specifically to FIG. 2, the digital memory 28 of the element 20 is a serial shift register that receives multi-bit digital values through a serial input 30 attached to the bus 60 (FIG. 1). The serial input 30 can be a row line 84 or column line 86. The multi-bit digital values are clocked into the digital memory 28 with the common clock signal 32. The stored multi-bit digital values are loaded into an up or down counter 22, for example using a logic circuit 29. (The up or down counter 22 can also be a digital memory 28. Although the counter 22 can be an up or down counter, it is more clearly explicated herein as a down counter that counts down to zero from a pre-determined value, but is not limited to a down counter embodiment.) The logic circuit 29 can also provide the clock signal 32 to the counter 22 after the multi-bit digital value is loaded to cause the counter 22 to increment or decrement. The logic circuit 29, the digital memory 28, and the counter 22 can be a common circuit, separate circuits, or any combination of circuits. The multi-bit digital value can have any number of bits greater than one. In various embodiments, the multi-bit digital value is a 2-bit value, a 3-bit value, a 4-bit value, a 6-bit value, or an

8-bit value. In the FIG. 2 example, the multi-bit digital value has four bits and the counter 22 is a 4-bit counter. The counter 22 counts down to zero when supplied with the clock signal 32 or a signal derived from the clock signal 32, such as a specific PWM clock, and maintains a zero output thereafter, even if additional clock signals 32 or derived clock signals are provided. In general, a variety of different clock signals, such as a PWM clock or data load or read signals, can be derived from a generic clock signal 32 to provide desired control or clock signals. Thus, the counter 22 can count at a frequency different from the clock rate at which the multi-bit-digital values are loaded into the digital memory 28 so that the multi-bit digital values can be loaded at a higher rate than the down counter 22 counts down. A cycle counter is provided, for example in the logic circuit 29 to clock the down counter 22 at least a number of times equal to  $2^n$  (two raised to the power of  $n$ ) where  $n$  is the number of bits in the multi-bit digital value. An OR logic circuit 24 receives the bits B0, B1, B2, and B3 output by the down counter 22 and provides an output enable signal 25 as long as the down counter 22 has a non-zero value. The enable signal 25 controls a drive circuit 26 (in this example connected to the gate of a drive transistor) that drives an output device 27 (in this example an LED). Other logic circuits can provide the functionality described in FIG. 2. FIG. 2 is only one example of a logic circuit useful for the present invention. Various portions of the circuits described can be integrated into a common circuit or divided into separate circuits or can be implemented according to different designs. For example, the digital memory/serial shift register 28 and down counter 22 can be combined into a single universal counter and are illustrated as separate elements for descriptive clarity.

[0075] Referring also to FIG. 7, according to an exemplary embodiment of the present invention, a method of operating the distributed pulse-width modulation system 10 of the present invention includes first providing multi-bit digital value, for example pixel values from an image frame of an image sequence, to the system controller 40 and storing the multi-bit digital values in the memory 42 of the system controller 40 in step 100. Each pixel value is a multi-bit digital value specifying a desired luminance output over a period of time by the output device 27 of each element 20. Thus, in some embodiments, each element 20 corresponds to a pixel and is spatially located on the system substrate 82 in correspondence with the relative location of the pixel provided to the element 20 in the image so that the array of elements 20 forms a display for displaying the pixel values of the image. The multi-bit digital pixel values are loaded into the corresponding elements 20 by the system controller 40 in step 110 and the down counter 22 is set to the loaded multi-bit digital value in step 120. A cycle controller is also set to the value  $2^n$  where  $n$  is the number of bits in the multi-bit digital value. The cycle state is tested in step 160. If the cycle is done (cycle counter=0), the frame state is tested in step 170. If the frame is done, a new set of multi-bit digital values from the image sequence is loaded and the process starts over (step 100). If the frame is not done the output cycle is repeated (step 120).

[0076] If the cycle is not done, the counter value is tested in step 140 and, if it is not zero, the output is enabled in step 150, the down counter 22 is decremented in step 130, and the cycle counter is decremented in step 180, responsive to the clock signal 32. The test process is then repeated by testing

the cycle state in step 160. If the counter value is zero, the cycle counter is decremented in step 180 and the test process is repeated by testing the cycle state in step 160. The time required to count down the cycle counter can be less than a frame time period (to reduce flicker).

[0077] In some embodiments, the system controller 40 includes a timing circuit 46 (for example, as in FIG. 1) for providing timing signals to each element 20. The time period can be formed with a counter controlled by the timing signal. Alternatively, the element 20 can include a timing circuit (for example in logic circuit 29) to provide a derived clock signal used by the down counter 22. The timing signals can control the rate at which the output device 27 is driven in response to the multi-bit digital value stored in the digital memory 28 and can be different from the rate at which data is loaded into the array of elements 20. For example, the multi-bit digital values can be loaded at a 1 MHz rate. The least-significant bit of the multi-bit digital value can correspond to a 1 msec time period and the clock signal 32 (or derived clock signal) can have a corresponding 1 msec period so that the down counter 22 decrements at a 1 kHz frequency. Therefore, the output device 27 can be enabled for any time period from zero to 15 msec depending on the multi-bit digital value provided to the down counter 22. Thus, the element 20 provides a pulse-width modulation of the output device 27. Any frequency compatible with the element 20 hardware can be provided by the system controller 40 so that different pulse rates can be used according to the desired application of the distributed pulse-width modulation system 10, for example 10 kHz or 100 kHz.

[0078] Pulse-width modulation is usefully employed with light-emitting diodes, since light-emitting diodes tend to have an optimum current and voltage operating parameter at which the LED performance is optimal for some operating characteristic, for example efficiency, or the LED current-to-illuminance transfer function is non-linear. Thus, it is an advantage in some applications to provide a constant power to the output device 27 and to modulate the output device 27 output using temporal modulation, such as pulse-width modulation, to provide variable output over a period of time greater than the minimum pulse width period, for example to provide variable luminance. Thus, in some embodiments, the drive circuit 26 provides a voltage or a current corresponding for a portion of a time period corresponding to the value of the multi-bit digital value and provides a constant current or voltage that is supplied to the output device 27 for that time period.

[0079] According to further embodiments of the present invention, different clock rates are provided to the elements 20 to provide different operating time periods corresponding to different portions of a single digital value. In such embodiments, the system controller 40 includes a memory 42 for storing a full-bit digital value for each element 20. The full-bit digital value includes a plurality of multi-bit digital values, and the communication circuit 44 communicates each multi-bit digital value to each corresponding element 20 sequentially. The full-bit digital value is the desired output value for the output devices 27 over a time period, for example a frame period. For example, a full-bit digital value can be an 8-bit value having values ranging from zero to 255 and representing a range of luminance values from minimum luminance at zero to maximum luminance at 255 (i.e., from off to maximum brightness). If the multi-bit value loaded into the elements 20 has the same

number of bits as the full-bit digital value, a pulse-width modulation function is provided as described above with respect to FIG. 2 and FIG. 7.

**[0080]** However, in other embodiments, the digital memory 28 and the counter 22 in the elements 20 have fewer bits than the full-bit pixel value. For example, the full-bit digital value can be 8 bits but the digital memory 28 and the counter 22 in the elements 20 can store only 4 bits. In this case, the multi-bit digital value (the value that is loaded into the elements 20) is only 4 bits so that the full-bit digital value (having 8 bits) includes a plurality (two) of multi-bit digital values (of four bits each). In another example, the multi-bit digital value (the value that is loaded into the elements 20) is only 2 bits so that the full-bit digital value (having 8 bits) includes a plurality (four) of multi-bit digital values (of two bits each). It is not necessary that every multi-bit digital value have the same number of bits, so long as the digital memory 28 is sufficiently large for the bits in the largest multi-bit digital value. For example, if the full-bit digital value has 8 bits, the multi-bit values can be two bits, three bits, and three bits. The number of bits in each of the multi-bit digital values of a full-bit digital value must sum to the number of bits in the full-bit digital value. A full-bit digital value can be divided in different ways into different numbers of different multi-bit digital values. For example, if the full-bit digital value has 12 bits, the multi-bit values can include six two-bit multi-bit digital values, four three-bit multi-bit digital values, three four-bit multi-bit digital values, or six two-bit multi-bit digital values. In another example, if the full-bit digital value has 12 bits, the multi-bit values can include one three-bit multi-bit digital values, one five-bit multi-bit digital values, and one four-bit multi-bit digital values.

**[0081]** In a conventional binary numbering system as used by computer scientists, the bits in a number are labeled B0, B1, B2, and so on corresponding to the place of the bit in the binary number and arranged sequentially from right to left in a graphic numerical depiction. Each successive place to the left represents a value twice that of the previous place to the right. B0 is typically designated the least significant bit and has a place value of one. B1 is the next bit and has a place value twice that of B0, in this case two, and B2 has a place value twice that of B1, in this case four. Thus the  $n$ th bit has a place value equal to  $2^{n-1}$  and is conventionally designated as  $B(n-1)$ , where  $2^{n-1}$  (or  $2^n$ ) represents 2 raised to the  $n$ th power or 2 raised to the exponent  $n$ . The different multi-bit digital values making up a full-bit digital value therefore have different relative values depending on their relative places in the full-bit digital value. The least significant bit of each multi-bit digital value will have a value  $2^{n-1}$ , where  $n$  is the place of the least significant bit of the multi-bit digital value. For example, if the full-bit digital value has 8 bits and is made up of a first four-bit multi-bit digital value corresponding to the first lower four bits of the full-bit digital value (B0, B1, B2, B3), the second four-bit multi-bit digital values corresponding to the second upper four bits of the full-bit digital value (B4, B5, B6, B7) have a value  $2^4$  (equal to 16) greater than the first four-bit multi-bit digital value.

**[0082]** In a pulse-width modulated system, the values represent portions of a time period where the maximum value is equivalent to the maximum time period and the minimum value (typically zero) is equal to the minimum time period, typically zero time. One bit in the value is the

minimum change and is chosen to correspond to the desired minimum change in the chosen time period. Thus each multi-bit digital value in a full-bit digital value has a minimum period value corresponding to its least significant bit value. For example, in an 8-bit full-bit digital value system with two four-bit multi-bit values and where each bit in the value corresponds to one msec, each of the first four-bit multi-bit digital values (corresponding to bits B0, B1, B2, B3 of the full-bit digital value) represents a one-msec time period. However, each of the second four-bit multi-bit digital values (corresponding to bits B4, B5, B6, B7 of the full-bit digital value) represent a period equal to  $2^{n-1}$  where  $n=4$  so that the period represented by each value of the second four-bit multi-bit digital value is 16xone msec or 16 msecs.

**[0083]** FIGS. 3, 4, and 5 illustrate three different examples of multi-bit digital values making up a full-bit digital value applied to a distributed pulse-width modulated system 10 of the present invention. Referring to FIG. 3, a full-bit digital value has four bits made up of two two-bit multi-bit digital values. As shown, the first multi-bit digital values are supplied by the system controller 40 and loaded into the respective elements 20 during the Load  $M_0$  time period (corresponding to steps 100, 110, and 120 of FIG. 7). The clock signal 32 is then supplied for four cycles (equal to  $2^{n-1}$  where  $n$  is the number of bits in the first multi-bit digital value, two in this example) to cause the down counter 22 and cycle counter to decrement, and if the output of the down counter 22 is non-zero, the output device 27 is enabled (corresponding to steps 130, 140, 150, and 160 of FIG. 7) during the Count  $M_0$  time period. The second multi-bit digital values are then supplied by the system controller 40 and loaded into the respective elements 20 during the Load  $M_1$  time period (corresponding to steps 100, 110, and 120 of FIG. 7). The clock signal 32 is then supplied for 4 cycles (equal to  $2^{n-1}$  where  $n$  is the number of bits in the second multi-bit digital value, 2 in this example) to cause the down counter 22 and cycle counter to decrement during the Count  $M_1$  time period. If the output of the down counter 22 is non-zero, the output device 27 is enabled. However, for the second multi-bit digital value cycle, as shown in FIG. 3 the clock rate (or, more precisely, the PWM pulse rate) has a period equal to four times the period of the clock used for the first multi-bit digital value because the least significant bit of the second multi-bit digital value is the second bit B2 and four is equal to  $2^{n-1}$  where  $n$  equals 2, the place of the least significant bit of the second multi-bit digital value.

**[0084]** Referring to FIG. 4, a full-bit digital value has six bits made up of three two-bit multi-bit digital values. As shown, the first multi-bit digital values are supplied by the system controller 40 and loaded into the respective elements 20 during the Load  $M_0$  time period (corresponding to steps 100, 110, and 120 of FIG. 7). The clock signal 32 is then supplied for 4 cycles (equal to  $2^{n-1}$  where  $n$  is the number of bits in the first multi-bit digital value, 2 in this example) to cause the down counter 22 and cycle counter to decrement, and if the output of the down counter 22 is non-zero, the output device 27 is enabled (corresponding to steps 130, 140, 150, and 160 of FIG. 7) during the Count  $M_0$  time period. The second multi-bit digital values are then supplied by the system controller 40 and loaded into the respective elements 20 during the Load  $M_1$  time period. The clock signal 32 is then supplied for 4 cycles (equal to  $2^{n-1}$  where  $n$  is the number of bits in the second multi-bit digital value,

2 in this example) to cause the down counter 22 and cycle counter to decrement during the Count  $M_1$  time period. If the output of the down counter 22 is non-zero, the output device 27 is enabled. However, for the second multi-bit digital value cycle, the clock rate has a period equal to four times the period of the clock used for the first multi-bit digital value because the least significant bit of the second multi-bit digital value is the second bit B2 and four is equal to  $2^{**n}$  where n equals 2, the place of the least significant bit of the second multi-bit digital value. The third multi-bit digital values are then supplied by the system controller 40 and loaded into the respective elements 20 during the Load  $M_2$  time period. The clock signal 32 is then supplied for 4 cycles (equal to  $2^{**n}$  where n is the number of bits in the third multi-bit digital value, 2 in this example) to cause the down counter 22 and cycle counter to decrement during the Count  $M_2$  time period. If the output of the down counter 22 is non-zero, the output device 27 is enabled. However, for the third multi-bit digital value cycle, the clock rate has a period equal to 16 times the period of the clock used for the first multi-bit digital value because the least significant bit of the second multi-bit digital value is the fourth bit B4 and 16 is equal to  $2^{**n}$  where n equals 4, the place of the least significant bit of the third multi-bit digital value.

[0085] Referring to FIG. 5, a full-bit digital value has eight bits made up of two four-bit multi-bit digital values. As shown, the first multi-bit digital values are supplied by the system controller 40 and loaded into the respective elements 20 during the Load  $M_0$  time period (corresponding to steps 100, 110, and 120 of FIG. 7). The clock signal 32 is then supplied for 16 cycles (equal to  $2^{**n}$  where n is the number of bits in the first multi-bit digital value, 4 in this example) to cause the down counter 22 and cycle counter to decrement during the Count  $M_0$  time period, and if the output of the down counter 22 is non-zero, the output device 27 is enabled (corresponding to steps 130, 140, 150, and 160 of FIG. 7). The second multi-bit digital values are then supplied by the system controller 40 and loaded into the respective elements 20 during the Load  $M_1$  time period (corresponding to steps 100, 110, and 120 of FIG. 7). The clock signal 32 is then supplied for 16 cycles (equal to  $2^{**n}$  where n is the number of bits in the second multi-bit digital value, 4 in this example) to cause the down counter 22 and cycle counter to decrement during the Count  $M_1$  time period. If the output of the down counter 22 is non-zero, the output device 27 is enabled. However, for the second multi-bit digital value cycle, the clock rate has a period equal to 16 times the period of the clock used for the first multi-bit digital value because the least significant bit of the second multi-bit digital value is the fourth bit B2 and 16 is equal to  $2^{**n}$  where n equals 4, the place of the least significant bit of the second multi-bit digital value.

[0086] Thus, the first multi-bit digital value has a clock signal 32 with a first period and the second multi-bit digital value has a clock signal 32 with a second period that is related to the first period by the relative values of the lower bits and the upper bits in the full-bit digital value. In some embodiments, the second period has a length that is  $2^{**n}$  times the first period wherein n is the place value of the least significant bit in the second multi-bit digital value. During the counting period for each multi-bit digital value, the period of the clock signal 32 can be set by the timing circuit 46 of the system controller 40. Alternatively, the period of the clock signal 32 can be determined by the logic circuit 29,

for example by providing a frequency divider for the clock signal 32 used to drive the cycle counter and the down counter 22. Note that the clock signal 32 used to load data into the elements 20 can have a different frequency, for example much higher than the counting frequency to reduce the time spent loading data into the elements 20.

[0087] Referring to FIG. 8, in a method of the present invention, an array of full-bit digital values are provided, for example to the system controller 40 in step 102. The full-bit digital values can be pixel values, as indicated in FIG. 7 but as in FIG. 7 can be other values and are not necessarily pixel values. The number of multi-bit values is determined and the first multi-bit values and corresponding clock rate are initialized in step 105 and loaded into the elements 20 in step 115. The process of FIG. 7 then proceeds (pulse-width modulation control is provided to the output device 27 for the current multi-bit digital value). When it is concluded, a test is performed to determine whether other multi-bit digital values are to be processed in step 145. If so, the next set of multi-bit digital values and corresponding clock rates are calculated or provided in step 155 and then initialized or loaded into the elements 20 in step 115 and the process repeats until all of the multi-bit digital values comprising the full-bit digital value are operated. The frame status is checked in step 170 and if the frame is not done the process repeats with step 105. If the frame is done, new full-bit digital values are provided in step 102.

[0088] Thus, in a method of the present invention, an array of full-bit digital values is provided, each full-bit digital value including at least first and second multi-bit digital values. Each element 20 of the array of elements 20 is loaded with the first multi-bit digital value of the array of full-bit digital values and a first timing signal provided to each element 20. The timing signal and the first multi-bit digital value are combined to provide a control signal in each element 20, the control signal responsive to the value of the first multi-bit digital value, and the output device of each element 20 is driven in response to the control signal. Each element 20 of the array of elements 20 is loaded with the second multi-bit digital value of the array of full-bit digital values and a second timing signal provided to each element 20. The second timing signal and the second multi-bit digital value are combined to provide a control signal in each element 20, the control signal responsive to the value of the second multi-bit digital value, and the output device 27 of each element 20 is driven in response to the control signal.

[0089] The first and second timing signals can be the same timing signal and the different clock signal rates corresponding to the different first and second multi-bit digital values formed in the element 20 or, alternatively, different clock signal rates corresponding to the different first and second multi-bit digital values formed in the element 20 can be provided by the system controller 40, for example with the timing circuit 46.

[0090] The circuit of FIG. 2 will enable the output device 27 for an uninterrupted period of time corresponding to the value loaded into the down counter 22. After the down counter 22 has reached zero, the output device 27 will be uninterruptedly disabled for the remainder of the cycle. In alternative embodiments, the enabled and disabled periods can be alternated, reducing the appearance of flicker for a display application of the present invention. In such an alternative embodiment and referring to FIG. 6, the down counter 22 is a first counter and the elements 20 include a



second counter responsive to the timing signal. A control circuit alternates the signals from the first counter and the second counter so that the output device 27 is responsive to the alternating signal. As shown in FIG. 6, the element 20 includes two each of the digital memory 28, the down counter 22, and the OR logic circuit 24, except that the second counter is an up counter 23 while the first counter is a down counter 22 as in FIG. 2. The clock signal 32 is applied through an AND gate to a Toggle flip-flop that alternates state with each applied clock signal 32. The first state of the two states of the toggle flip-flop provides the output of the down counter 22 to the drive circuit 26 and the output device 27 (that can, for example, be the circuit shown in FIG. 2). The second state of the two states of the toggle flip-flop provides the output of the up counter 23 to the drive circuit 26 and the output device 27. The down counter 22 provides an enable signal when the down counted multi-bit digital value is non-zero; it counts the number of periods when the output device 27 should be enabled. The up counter 23 provides a disable signal when the up counted multi-bit digital value is non-zero; it counts the number of periods when the output device 27 should not be enabled. For example, for a four-bit multi-bit digital value of 12, the down counter 22 provides 12 periods when the output device 27 should be enabled and the up counter 23 provides 4 periods when the output device 27 should not be enabled. The circuit of FIG. 6 temporally intersperses the disabled periods and the enable periods.

[0091] The digital memories 28 are loaded together through the serial input 30 in response to the clock signal 32. (Loading logic is not shown but can be controlled by the logic circuit 29 in each counter.) The multi-bit digital values are then applied to the up and down counters 23, 22 using the logic circuit 29. Digital circuits for controlling serial shift registers, loading counters, and providing clock signals can be made using convention Boolean logic and available integrated circuit modules. Once the output of the up and down counters 23, 22 are combined through the respective OR logic circuit 24, operation of the output device 27 can begin. If both the up and down counters 23, 22 have a non-zero value, the Toggle flip-flop will respond to the clock signal 32 and alternately provide a signal to the AND gates on the inputs applied to the counters. If the Q output of the Toggle flip-flop is positive and the down counter 22 is clocked, its value is decremented and the Toggle flip-flop changes state to enable the clock input to the up counter. The next clock signal 32 will increment the up counter 23 and switch the Toggle state again. Thus, the up and down counters 23, 22 are alternately controlled by the Toggle flip-flop as long as they have non-zero contents. The delay circuits 25 prevent race conditions and ensure that the changes in Toggle flip-flop state do not inadvertently clock the up or down counters 23, 22. (Other logic designs can also prevent race conditions.) Once either of the up or down counters 23, 22 has a zero value, the Toggle flip-flop state is fixed so that the other counter is selected and responds to each clock signal 32. The up counter 23 counts up to the maximum value of the counter and then once more until it is at zero and then no longer responds to further clock signals 32. The down counter 22 counts down until it is at zero and then no longer responds to further clock signals 32. The Toggle flip-flop Q output (corresponding to the down counter state) is combined with the output of the down counter OR logic circuit 24 to provide an Enable signal for

the output device 27. The Toggle flip-flop QNOT output (inverse of output Q and corresponding to the up counter state) is combined with the output of the up counter OR logic circuit 24 to provide a disable signal for the output device 27. Thus, as long as the Toggle flip-flop is alternating states and the up and down counters 23, 22 are non-zero, the output device 27 will alternate between an on and off state. Once one of the up or down counters 23, 22 is at zero, the Toggle flip-flop state is fixed. Since the Enable and Disable signals are mutually exclusive, in some embodiments, it is not necessary to produce both, but they are both provided for clarity of exposition. The logic circuits of FIG. 6 are provided to demonstrate the concept of alternating enable and disable signals provided to the output device 27 and other circuit designs are possible and can be preferred.

[0092] The circuit embodiments of FIGS. 2 and 6 are exemplary and not limiting. Other circuit designs can implement the functions described and are included as part of the present invention.

[0093] In the embodiment of FIG. 2, each pulse-width modulation element 20 (also referred to as element 20) includes an output device 27 driven by a drive circuit 26 associated with each digital memory 28 and a PWM counter 22 (also referred to as down counter 22). In an alternative embodiment, referring to FIG. 9, a distributed pulse-width modulation system 10 includes an array 12 of pulse-width modulation elements 20. Each pulse-width modulation element 20 includes a digital memory 28 for storing a plurality of multi-bit digital values, a drive circuit 26 for each stored multi-bit digital value, and an output device 27 for each stored multi-bit digital value. The multi-bit digital values all have the same maximum number of bits, for example 8 bits, 10 bits, 12 bits, 14 bits, or 16 bits. Each multi-bit digital value can store a different number ranging from zero to  $2^n - 1$  where n is the number of bits in the multi-bit digital value. For each stored multi-bit digital value, the corresponding drive circuit 26 drives the corresponding output device 27 in response to the multi-bit digital value stored in the digital memory 28. A system controller 40 includes a memory 42 for storing the multi-bit digital values for each element 20 and a communication circuit 44 for communicating each multi-bit digital value to each corresponding pulse-width modulation element 20. The digital memory 28 can be a common memory for all of the multi-bit digital values in the element 20 (as shown) or can include a plurality of separate memories, for example a separate memory for each multi-bit digital values. Similarly, the drive circuits 26 can be entirely separate circuits (as shown), or can have portions or components in common. The dashed lines joining circuit elements in FIG. 9 (and in some of the following figures) indicate that multiple, similarly connected additional circuit elements are included in the circuit. The system controller 40 can include a timing circuit 46 for providing timing signals, for example clock signals, to each element 20. The timing signals can control the rate at which the output devices 27 are driven in response to the multi-bit digital values stored in the digital memory 28.

[0094] The digital memories 28 in the elements 20 can take a variety of forms according to a corresponding variety of embodiments. In the embodiment of FIG. 2, the digital memory 28 is a serial shift register with a parallel output. A down counter 22 provides the pulse-width modulation timing for activating the output device 27. The digital memory 28 and the down counter 22 can be incorporated into a

common device or circuit. In these embodiments, a separate down counter 22 is required for each multi-bit digital value.

[0095] In an alternative embodiment, referring to FIG. 10, the digital memory 28 also includes one or more registers, in this case registers with serial input 30 and parallel output. For clarity in understanding, separate registers are shown for each multi-bit digital value, but the registers can also be considered as one long serial shift register with parallel outputs. In other embodiments, separate registers can be loaded through separate serial input lines 30 or can be loaded in parallel through multiple input lines (not shown). In the embodiment of FIG. 10, the multi-bit digital values are serially input by the registers forming the digital memory 28 and are shifted into the registers with a load clock signal, for example provided by the timing circuit 46 of the system controller 40. In the embodiment of FIG. 10, the multi-bit digital values are 10-bit values but any number of bits greater than one can be used, for example 12, 14, or 16 bits.

[0096] The element 20 of FIG. 10 includes only a single pulse-width modulation up or down counter 22 for providing pulse-width modulation timing for all of the multi-bit digital values stored in the digital memory 28. By using only one counter 22, the element 20 requires less circuitry and has a lower cost in a smaller integrated circuit package. Rather than counting down the value of each multi-bit digital value with a separate down counter 22 (e.g., as in FIG. 2), the down counter 22 provides a single pulse-width modulation down-counted counter output that is compared to each of the multi-bit digital values in the digital memory 28 with a comparator circuit 90. The output of the comparator circuit 90 is supplied to the drive circuit 26 to drive the output device 27 so that each drive circuit 26 and output device 27 are responsive to a corresponding multi-bit digital value. The down counter 22 is also referred to as a PWM counter 22 to distinguish it from a cycle counter 98 described below and is responsive to a PWM clock 32 (clock signal 32), for example as provided from the timing circuit 46 of the system controller 40.

[0097] Once the multi-bit digital values are loaded into the digital memory 28, each register presents all of the bits of the stored multi-bit digital value at the same time on parallel output lines and the pulse-width modulation cycle can begin. Each of the stored bits is combined with the corresponding bit of the PWM counter 22 with a logical AND and the output of each logical AND bit combination is combined in a multi-input AND gate whose output is HIGH only if each of the bits in the stored multi-bit digital value matches the corresponding bit of the PWM counter 22 counter output.

[0098] An output state flip-flop 92 or latch stores the output state. The output state flip-flop 92 is illustrated as a T flip-flop for simplicity and understanding, since its state toggles between off and on, but the output state flip-flop 92 can be a T flip-flop, an SR flip-flop, a D flip-flop, or a latch. If the output state is off (for example the output state flip-flop 92 stores a LOW value), the output device 27 does not output a signal. If the output state is on (for example the output state flip-flop 92 stores a HIGH value), the output device 27 does output a signal. At the beginning of a PWM cycle, for example at the commencement of a frame period in a display, just after the multi-bit digital values are loaded into the digital memory 28, or following a counting cycle reaching a count output of zero, the output state flip-flop 92 can be set to an off (LOW) state, for example with the PWM counter reset signal as shown. The PWM counter reset signal

sets the PWM counter 22 to its maximum value (e.g., 1023 for a 10-bit multi-bit digital value) for example by providing a PWM clock 32 signal when the PWM counter 22 stores a zero value. The bits representing this maximum value (all 1s) are compared to the actual multi-bit digital value. If a match is found, the T flip-flop making up the output state flip-flop 92 toggles into a HIGH state and the output device 27 is turned on. (An inverted clock signal is combined with the comparison signal using an AND gate to clock the output state flip-flop 92 to allow the comparator circuit 90 to settle and avoid race conditions.) If a match is not found, the output state of the output state flip-flop 92 is not changed and the output device 27 remains off. In either case, the PWM counter 22 counts down one value in response to the PWM clock 32 and a comparison is performed again and the process is repeated. Thus, the output state flip-flop 92 remains in an off state until a match is found and once a match is found, the output state flip-flop 92 remains in an on state until the PWM clock finishes counting down (since only one match can be found) after which the output state flip-flop 92 is reset and the process begins again. Thus, the output device 27 is off until a match is found and remains on until the counter output of the PWM counter 22 reaches zero. Therefore, the output device 27 is on for as many PWM clock 32 cycles as is the number stored in the digital memory 28 and is off for the remaining cycles. The PWM counter reset signal can be responsive to a zero value in the PWM counter 22. Since all of the bits in the multi-bit digital value and all of the bits in the PWM counter 22 are compared at the same time, the comparator circuit 90 is a parallel comparator.

[0099] Referring next to FIG. 11, a similar result can be achieved using a content addressable memory (CAM) as the digital memory 28. A content addressable memory is a memory that provides a signal (for example a HIGH signal) when the CAM stores a value equal to the value provided to the CAM's input. A CAM can require a smaller circuit than a register but can also require more power to operate. As shown in FIG. 11, read, write, and data signals provide a way to load multi-bit digital values into the CAM. Once the multi-bit digital values are loaded, the output state flip-flop 92 can be reset to an off state and the PWM counter 22 can count down and provide the counter output to the CAM inputs. If a match is found between the counter output and a multi-bit digital value, the output state flip-flop 92 is toggled from an off state to an on state. In this embodiment, the CAM incorporates both the digital memory 28 and the comparator circuit 90. The drive circuit 26 operates as described above with respect to FIG. 10 as does the pulse-width modulation control. The comparator circuit 90 in the embodiment of FIG. 11 is also a parallel comparator.

[0100] In contrast to the embodiments of FIGS. 10 and 11, the embodiment of FIG. 12 uses a serial comparator. In this embodiment, the digital memory 28 is a random access memory (RAM) such as a static random access memory (SRAM). An SRAM can require a smaller circuit than registers on a CAM but can require a higher frequency clock to perform serial bit comparisons and can thus require more power. As shown in FIG. 12, read, write, and data signals can control the SRAM to load the multi-bit digital values into the SRAM in bit planes so that each SRAM address, generated by the bit address circuit, stores a common bit of each of the multi-bit digital values. Thus, for 10-bit multi-bit digital values, address 0 can store bit 0 of the multi-bit digital

values, address 1 can store bit 1 of the multi-bit digital values, address 2 can store bit 2 of multi-bit digital values and so on. The PWM counter 22 operates as in the embodiments of FIGS. 10 and 11. However, rather than providing the counter output in parallel to a parallel comparator circuit 90, the counter output is provided to a bit select circuit responsive to a bit clock signal in concert with the bit address generation circuit. The bit clock provides as many signals as bits in the multi-bit digital values for each PWM clock 32 signal. The bit select circuit selects the counter output bit corresponding to the address provided by the bit address circuit. Thus, if the bit address generates the address of multi-bit digital value bit 0 in the CAM, the bit select circuit selects bit 0 of the PWM counter output. If the bit address generates the address of multi-bit digital value bit 1 in the CAM, the bit select circuit selects bit 1 of the PWM counter output, and so on. The multi-bit digital value bit (designated as Bx in FIG. 12) and the counter output bit (designated as Cx in FIG. 12) are presented as inputs to the serial comparator 91.

[0101] The serial comparator 91 uses an exclusive NOR (XNOR) circuit to compare the multi-bit digital value bit and the counter output bit and produce a HIGH signal when the multi-bit digital value bit and the counter output bit are the same (i.e., both LOW or both HIGH). A serial state flip-flop 94 (indicating the state of the comparison) is initially set to a HIGH value and the state of the serial state flip-flop 94 is combined with the XNOR output. If the XNOR output is HIGH, the state of the serial state flip-flop 94 remains high when clocked by the selected edge of the bit clock (to provide time for the circuit to settle and avoid race conditions. If the XNOR output is LOW, the state of the serial state flip-flop 94 changes to LOW. Since the state of the serial state flip-flop 94 is now LOW and is combined with the XNOR output as an input to the serial state flip-flop 94, the serial state flip-flop 94 output will remain LOW until it is reset. The bit clock then operates to increase the bit address and bit selection and present the next multi-bit digital value bit and PWM counter output bit to the XNOR circuit and the process repeats until all of the bits in the multi-bit digital value and the PWM counter output have been compared. The state of the serial state flip-flop 94 will only remain HIGH if all of the bits in the multi-bit digital value match the bits in the PWM counter 22. Once all of the bits have been compared, the state of the serial state flip-flop 94 is clocked into the output state flip-flop 92 with the bit address reset signal that restarts the comparison process. If the state of the serial state flip-flop 94 is HIGH (indicating a match between the multi-bit digital value and the PWM counter 22 output), the output state flip-flop 92 will toggle into a HIGH state. If there is no match, the clock input of the output state flip-flop 92 will not go HIGH and the state of the output state flip-flop 92 will not change. Since only one match between the multi-bit digital value and the PWM counter 22 output is possible, the output state flip-flop 92 cannot toggle back into a LOW (off) state until it is reset. Thus, as in the embodiments of FIGS. 10 and 11, the state of the output state flip-flop 92 will remain LOW until a match with the PWM counter 22 output is established, after which the output state flip-flop 92 will transition HIGH until it is reset, providing a pulse-width modulation signal responsive to the multi-bit digital value.

[0102] (References to HIGH or LOW, TRUE or FALSE, or ON or OFF logic levels are arbitrary designations and can

be exchanged or the logic signals inverted in alternative circuit designs and such designs are included in the present invention. The logic signals can correspond to relatively high or low voltages in a logic circuit such as a CMOS circuit.)

[0103] FIG. 13 is a schematic of a pulse-width modulation element 20 of a distributed pulse-width modulation system having 10-bit multi-bit digital values, an SRAM digital memory 28, a serial comparator 91, and light emitter 50 comprising 48 output devices 27 (iLEDs). Although not explicitly shown in FIG. 13, the 48 output devices 27 can correspond to 16 three-color pixels arranged in a 4x4 array on a display substrate (system substrate 82, FIG. 1). This distributed pulse-width modulation system 10 has been simulated and demonstrated to operate satisfactorily. As shown in FIG. 13, a control state machine provides control signals to control the various elements of the distributed pulse-width modulation system 10. Four column data inputs are provided. A 10-bit counter (PWM counter 22) provides pulse-width modulation time signals. With four column data inputs, each column data input will receive twelve 10-bit serial input values, or 120 bits each.

[0104] The SRAM digital memory 28 is arranged in 48 columns of 10 bits each. Each column is selected with a 1-of-12 column decoder and selection circuit. The PWM counter is used during SRAM data load as a four-bit column selector counter and is not needed for PWM counting during this time. Thus, the first 10-bit serial value is input to column 1, the second 10-bit serial value is input to column 2, and so forth, for each of the four column data inputs. At the same time, the 4-bit word counter counts from 0 to 9 (for 10 bits) and the corresponding bit address is selected by the 1-of-10 word line decoder. Together, the column select and word line decoder circuits enable a serial bit stream to be properly loaded into the SRAM digital memory 28. The data is loaded so that, for example, address zero stores the zero bit of each of the 48 digital values in parallel, address one stores the one bit of each of the 48 digital values in parallel, and so forth.

[0105] Once the data is loaded into the SRAM digital memory 28, it is read, one bit plane at a time, providing 48 values in parallel. The word line decoder provides the SRAM digital memory 28 address so that the corresponding bit is output. The corresponding bit of the PWM counter 22 output is selected by the 1-of-10 bit selector and the bits are compared, for example using the serial comparator 91 of FIG. 12. The next bit is then addressed and selected until the entire 10-bit word is compared. The PWM counter 22 then advances to the next counter output value and the process is repeated, as described above, until all of the PWM counter 22 values are compared and the PWM counter 22 reaches zero. The drive circuit 26 is then reset, as described above, and the process repeats.

[0106] In some embodiments of the present invention, a frame time corresponds to each full count cycle of the PWM counter 22, so that new data is loaded before each time the PWM counter 22 counts down. In alternative embodiments, the PWM counter 22 counts down multiple times between each new data set is loaded in the SRAM digital memory 28 so that multiple cycles of data are output for each data set. These multiple cycles can be controlled by a cycle counter 98. The cycle counter 98 can be separate from the PWM counter 22 (as shown) or the cycle counter 98 and the PWM counter 22 are part of a common counter. In either case, the PWM counter 22 is operating with the cycle counter 98 to

provide multiple cycles of PWM timing signals for the multi-bit digital values, for example in collaboration with the communication circuit 44 and timing circuit 46. In some embodiments, the cycle counter 98 and PWM counter 22 are part of a common counter that is set to a desired value each time new data is loaded into the SRAM digital memory 28 and when the common counter reaches zero, new data is loaded into the SRAM digital memory 28. As the counter corresponding to the lower bits of the common counter, the PWM counter 22 will complete an entire count cycle each time the cycle counter 98 decrements. When the cycle counter 98 and PWM counter 22 together decrement to zero (the common counter equals zero), the process for one data set is complete.

[0107] FIG. 14 is a layout for the circuit of FIG. 13. The SRAM digital memory 28 is divided into two portions, as are the serial comparators 91, and the drive circuit 26. This circuit has an area of approximately 100 microns by 100 microns on a crystalline silicon substrate in a 0.18-micron photolithography process. The circuit has an area of approximately 63 microns by 63 microns in a 90-nm process.

[0108] In some embodiments of the present invention, a method of operating the distributed pulse-width modulation system 10 includes loading the multi-bit digital values into the digital memory 28 of each element 20 and then driving each output device 27 in response to the corresponding multi-bit digital value. Such a system 10 is a digital system, can be a digital drive system, or can be a digital display, since the communicated and stored data is digital and every module in the system is digitally controlled. In a more detailed embodiment, referring to FIG. 15, a method of operating the distributed pulse-width modulation system 10 includes loading the multi-bit digital values into each element 20 in step 200. If a cycle counter 98 is used, it is set to the desired cycle count in step 210, the PWM counter 22 is set to an initial count value, in step 220. In the case in which the PWM counter 22 operates as a down counter, the initial count value can be at least as large as the largest possible multi-bit digital value, the maximum value, and the output device 27 is turned off in step 230. For example, in a 10-bit multi-bit system, the ten bits of the counter can be turned on (i.e., set to 1023) and then controlled to count down to zero, as illustrated. In the case in which the PWM counter 22 operates as an up counter, the initial count value can be set to zero and the output device 27 is turned on in step 230 (not shown). For example, in a 10-bit multi-bit system, the ten bits of the counter can be turned off (i.e., set to 0) and then controlled to count up to 1023 (not shown).

[0109] Steps 220 and 230 can be interchanged. This resets the system to begin a PWM output cycle. The PWM counter 22 is optionally operated in step 240 to count (e.g., with an enable control signal) and the counter output is compared to each multi-bit digital value with the comparator circuit 90 (either in parallel with all of the bits at once or serially bit by bit) in step 250. If the PWM counter 22 output matches the multi-bit digital value (step 260), each output device 27 is driven with the drive circuit 26 to output a signal, for example light output from an LED, in step 270, in the down counter case of the PWM counter 22. The PWM counter 22 is then decremented in step 280 and tested in step 290. If the PWM counter 22 does not equal zero, the comparison process is repeated. If the PWM counter 22 equals zero, then the cycle counter 98 (if present) is also decremented in step 300 and tested in step 310.

[0110] In the up counter case of the PWM counter 22 (not shown), the output device 27 is driven with the drive circuit 26 to cease outputting a signal in step 270. The PWM counter 22 is then incremented in step 280 and tested in step 290. If the PWM counter 22 does not equal the maximum value, the comparison process is repeated. If the PWM counter 22 equals the maximum value, then the cycle counter 98 (if present) is also decremented in step 300 and tested in step 310.

[0111] In the down counter case of the PWM counter 22, the PWM counter 22 is set to the maximum value, the output device 27 is turned off, the PWM counter 22 counts down until a match is found with the stored multi-bit digital value, the output device 27 is turned on, and the PWM counter 22 counts down to zero, at which point the PWM cycle is complete. In the up counter case of the PWM counter 22, the PWM counter 22 is set to zero (or one), the output device 27 is turned on, the PWM counter 22 counts up until a match is found with the stored multi-bit digital value, the output device 27 is turned off, and the PWM counter 22 counts up to the maximum value, at which point the PWM cycle is complete. In the down counter case the output device 27 is turned off and then on for the desired time (as shown). In the up counter case the output device 27 is turned on for the desired time and then turned off (not shown).

[0112] If the cycle counter is not equal to zero, the PWM counter 22 process is repeated for another cycle. If the cycle counter does equal zero, then the cycle process is complete and new data can be loaded and the cycle counter reset. In display terms, when the cycle counter equals zero, a new frame time can begin, for example by loading new data (e.g., a new image) from the communication circuit 44.

[0113] Thus, in the case in which each comparator circuit 90 is a parallel comparator 90 and the digital memory 28 includes registers having parallel register outputs, a method of the present invention includes simultaneously comparing each bit of the multi-bit digital value in the corresponding register to the corresponding bit of the PWM counter 22 output with the corresponding parallel comparator 90 and driving each output device 27 to output a signal with the corresponding drive circuit 26 in response to a match between the corresponding multi-bit digital value and the PWM counter 22 output.

[0114] Referring to FIG. 16, if the comparator is a serial comparator 91, each bit of the multi-bit digital value is sequentially compared to the PWM counter 22 output. The bit order is arbitrary but can be from low bit to high bit or high bit to low bit, as in this example. The state of the comparison is stored in the serial state flip-flop 94 (FIG. 12) and is initially set to a TRUE or match state in step 251. The bit counter (bit address generator) generates a multi-bit digital value bit and is set to the number of bits in the multi-bit digital value in step 252 and optionally enabled in step 253. In step 254, the PWM counter 22 bit is compared to the corresponding multi-bit digital value bit indicated by the bit counter. If a match (step 255) is found, the bit counter is decremented to the next bit in step 257 and, if the bit count is not zero (step 258) the comparison repeated for the next bit. If a match is not found, the comparison state of the serial state flip-flop 94 is set to FALSE in step 256, indicating that the PWM counter 22 output does not match the multi-bit digital value, and the bit counter decremented in step 257. If the bit count reaches zero, step 258, the serial comparison process is complete.

[0115] Thus, in the case in which each comparator is a serial comparator 91 and the digital memory 28 is a random access memory storing the bits of each multi-bit digital value at a common address in corresponding bit planes, a method of the present invention includes sequentially comparing each bit of the multi-bit digital values to the corresponding bit of the PWM counter 22 output with the corresponding serial comparator 91 and driving each output device 27 to output a signal with the corresponding drive circuit 26 in response to a match between the corresponding multi-bit digital value and the PWM counter 22 output.

[0116] In some embodiments of the present invention, the drive circuit 26 includes an output state, for example stored in an output state flip-flop 92, as shown in FIGS. 10-12. The output state flip-flop 92 indicates and controls whether the output device 27 is off or on and, at the beginning of each frame is initially set to the off state, for example responsive to the PWM counter output equaling zero. When the PWM counter 22 output equals the stored multi-bit digital value, the output state flip-flop 92 is turned on.

[0117] FIG. 17 illustrates a behavioral RTL logic simulation of the embodiment of the present invention shown in FIGS. 13 and 14. This simulation uses a single ASIC (application-specific integrated circuit) active-matrix drive to a 4×4 sub-array or block of pixels having one row input wire and four column input wires to the 4×4 block. The ASIC receives data on a row basis on all 4 columns in parallel so that the block data is loaded in four row times or 1/540 of frame rate. Each pixel is driven by a 10-bit PWM control signal generated in the ASIC with a constant current. The data is single-buffered resulting in a progressive scan image.

[0118] A row pulse is generated to reset the ASIC and prepare for data. A zero data signal is sent on all columns to identify the start of data (a reset or start signal). A sequence of 12 10-bit serial words starting with value of 0 and counting by 1 up to 11 is sent for each column in parallel. The design goal is to enable the LEDs with pulse widths ranging from 0 to 11 clock pulses wide. At the end of the serial data communication, the PWM generator creates PWM output pulses using an up-counting mode so that Led[0] pulse width is zero resulting in no pulse, Led[1] pulse width is one clock wide, and so forth so that the Led[11] pulse width is 11 clocks wide. PWM clocks are shown as transitions on the maincount variable.

[0119] Embodiments of the present invention can be made using conventional integrated circuit and printed circuit board materials and tools. Alternatively, some or all of the elements 20 can be provided in one or more chiplets 21, integrated circuits, or discrete parts some or all of which can be disposed on the system substrate 82 using micro-transfer printing techniques. In other embodiments, the one or more chiplets 21, integrated circuits, or discrete parts can be micro-transfer printed onto a module substrate and electrically interconnected on the module substrate. The module substrate can then be disposed onto the system substrate 82, either by conventional means or by micro-transfer printing, and electrically interconnected to make the distributed pulse-width modulation system 10 of the present invention. The chiplets 21 or integrated circuits can be supplied as bare die or unpackaged integrated circuits suitable for micro-transfer printing from a source wafer, such as a semiconductor wafer. Output devices 27 (e.g., light emitters such as LEDs) can be provided on a different semiconductor wafer

and transferred to a common substrate with the circuit components (for example CMOS on silicon) providing some or all of the elements 20 to provide a heterogeneous structure. Electrical interconnections can be made using conventional photolithographic methods.

[0120] The system controller 40 can be one or more integrated circuits and can, for example, include an image frame store, digital logic, input and output data signal circuits, and input and output control signal circuits such as communication circuits 44, control circuits, and a clock signal 32 (e.g., as part of the timing circuit 46). The communication circuit 44 can drive row lines 84 and column lines 86 to provide sequential rows of multi-bit digital values to corresponding selected rows of elements 20. The system controller 40 can include an image frame store memory for storing digital pixel and calibration values. The system controller 40 can have a display controller substrate separate and distinct from the system substrate 82 that is mounted on the system substrate 82 or is separate from the system substrate 82 (as shown in FIG. 1) and connected to it by a wire bus 60, for example with ribbon cables, flex connectors, or the like.

[0121] In various embodiment of the present invention, the digital memory 28 is a multi-bit memory with various numbers of bits in various embodiments of the invention.

[0122] The elements 20 and the light emitters can be made in one or more integrated circuits having separate, independent, and distinct substrates from the system substrate 82. The elements 20 can be or include one or more chiplets 21—small, unpackaged integrated circuits such as unpackaged dies interconnected with wires connected to contact pads on the chiplets. The chiplets can be disposed on an independent substrate, such as the system substrate 82. In some embodiments, the chiplets are made in or on a semiconductor wafer and have a semiconductor substrate. The system substrate 82 or a module substrate can include glass, resin, polymer, plastic, or metal. Alternatively, the module substrate is a semiconductor substrate and the digital memory 28 or the drive circuit 26 are formed in or on and are native to the module substrate. The output devices 27 and portions of the circuit of the elements 20 can be disposed on the module substrate to form a heterogeneous module. The module is typically much smaller than the system substrate 82. Semiconductor materials (for example silicon or GaN) and processes for making small integrated circuits are well known in the integrated circuit arts. Likewise, backplane substrates and means for interconnecting integrated circuit elements on the backplane are well known in the display and printed circuit board arts. The chiplets can be applied to the display substrate 50 or to the module substrate using micro transfer printing.

[0123] The chiplets or modules can have an area of, for example, 50 square microns, 100 square microns, 500 square microns, or 1 square mm and can be only a few microns thick, for example, 5 microns, 10 microns, 20 microns, or 50 microns thick.

[0124] In one method of the present invention, the elements 20 (or portions thereof) or the light emitters are disposed on the system substrate 82 by micro transfer printing. In another method, the elements 20 (or portions thereof) or the light emitters are disposed on the module substrate to form a heterogeneous module and the modules are disposed on the system substrate 82 using compound micro assembly structures and methods, for example as

described in U.S. patent application Ser. No. 14/822,868 filed Aug. 10, 2015, entitled Compound Micro-Assembly Strategies and Devices. However, since the modules are larger than the chiplets or light emitters, in another method of the present invention, the modules are disposed on the system substrate **82** using pick-and-place methods found in the printed-circuit board industry, for example using vacuum grippers. The modules can be interconnected with the system substrate **82** using photolithographic methods and materials or printed circuit board methods and materials.

**[0125]** In certain useful embodiments the system substrate **82** includes material, for example glass or plastic, different from a material in an integrated-circuit substrate, for example a semiconductor material such as silicon or GaN. The light emitters can be formed separately on separate semiconductor substrates, assembled onto the module substrates and then the assembled unit is located on the surface of the system substrate **82**. This arrangement has the advantage that the elements **20** can be separately tested on the module substrate and the modules accepted, repaired, or discarded before the module is located on the system substrate **82**, thus improving yields and reducing costs.

**[0126]** In some embodiments, the drive circuits **26** drive the output devices **27** (e.g., **50R**, **50G**, **50B**) with a current-controlled drive signal. The drive circuits **26** can convert a multi-bit digital value such as a pixel value to a current drive signal, thus forming a bit-to-current converter. Current-drive circuits, such as current replicators, can be controlled with a pulse-width modulation scheme whose pulse width is determined by the multi-bit digital value. A separate drive circuit **26** can be provided for each light emitter, or a common drive circuit **26**, or a drive circuit **26** with some common components can be used to drive the light emitters in response to the multi-bit digital values stored in the digital memory **28**. Power connections, ground connections, and clock signal connections can also be included in the elements **20**.

**[0127]** In embodiments of the present invention, providing the system controller **40** and the elements **20** can include forming conductive wires (e.g., row lines **84** and column lines **86**) on the system substrate **82** or module substrate by using photolithographic and display substrate processing techniques, for example photolithographic processes employing metal or metal oxide deposition using evaporation or sputtering, curable resin coatings (e.g. SU8), positive or negative photo-resist coating, radiation (e.g. ultraviolet radiation) exposure through a patterned mask, and etching methods to form patterned metal structures, vias, insulating layers, and electrical interconnections. Inkjet and screen-printing deposition processes and materials can be used to form patterned conductors or other electrical elements. The electrical interconnections, or wires, can be fine interconnections, for example having a width of less than 50 microns, less than 20 microns, less than 10 microns, less than five microns, less than two microns, or less than one micron. Such fine interconnections are useful for interconnecting chiplets, for example as bare dies with contact pads and used with the module substrates. Alternatively, wires can include one or more crude lithography interconnections having a width from 2  $\mu\text{m}$  to 2 mm, wherein each crude lithography interconnection electrically connects the modules to the system substrate **82**.

**[0128]** In some embodiments, the red, green, and blue light emitters **50R**, **50G**, **50B** (e.g. micro-LEDs) are micro transfer printed to the module substrates or the system

substrate **82** in one or more transfers. For a discussion of micro-transfer printing techniques see U.S. Pat. Nos. 8,722,458, 7,622,367 and 8,506,867, each of which is hereby incorporated in their entirety by reference. The transferred light emitters are then interconnected, for example with conductive wires and optionally including connection pads and other electrical connection structures, to enable the system controller **40** to electrically interact with the light emitters to emit light in the digital-drive distributed pulse-width modulation system **10** of the present invention. In alternative embodiments of the process, the transfer of the light emitters is performed before or after all of the conductive wires are in place. Thus, in embodiments the construction of the conductive wires can be performed before the light emitters are printed or after the light emitters are printed or both. In some embodiments, the system controller **40** is externally located (for example on a separate printed circuit board substrate) and electrically connected to the conductive wires using connectors, ribbon cables, or the like comprising the bus **60**. Alternatively, the system controller **40** is affixed to the system substrate **82** outside the display area, for example using surface mount and soldering technology, and electrically connected to the conductive wires using wires and buses formed on the system substrate **82**.

**[0129]** In some embodiments of the present invention, an array of elements **20** (e.g., as in FIG. 1) can include 40,000, 62,500, 100,000, 500,000, one million, two million, three million, six million or more display pixels **20**, for example for a quarter VGA, VGA, HD, or 4k display having various resolutions. In some embodiments of the present invention, the light emitters can be considered integrated circuits, since they are formed in a substrate, for example a wafer substrate, using integrated-circuit processes.

**[0130]** The system substrate **82** usefully has two opposing smooth sides suitable for material deposition, photolithographic processing, or micro-transfer printing of micro-LEDs. The system substrate **82** can have a size of a conventional display, for example a rectangle with a diagonal of a few centimeters to one or more meters. The system substrate **82** can include polymer, plastic, resin, polyimide, PEN, PET, metal, metal foil, glass, a semiconductor, or sapphire and have a transparency greater than or equal to 50%, 80%, 90%, or 95% for visible light. In some embodiments of the present invention, the light emitters emit light through the system substrate **82**. In other embodiments, the light emitters emit light in a direction opposite the system substrate **82**. The system substrate **82** can have a thickness from 5 to 10 microns, 10 to 50 microns, 50 to 100 microns, 100 to 200 microns, 200 to 500 microns, 500 microns to 0.5 mm, 0.5 to 1 mm, 1 mm to 5 mm, 5 mm to 10 mm, or 10 mm to 20 mm. According to embodiments of the present invention, the system substrate **82** can include layers formed on an underlying structure or substrate, for example a rigid or flexible glass or plastic substrate.

**[0131]** In some embodiments, the system substrate **82** can have a single, connected, contiguous system substrate area that includes the elements **20** and the output devices **27** each have a functional area. The combined functional area of the plurality of output devices **27** is less than or equal to one-quarter of the contiguous system substrate area. In further embodiments, the combined functional areas of the plurality of output devices **27** is less than or equal to one eighth, one tenth, one twentieth, one fiftieth, one hundredth, one five-hundredth, one thousandth, one two-thousandth, or

one ten-thousandth of the contiguous system substrate area. The functional areas of the output devices **27** can be only a portion of the element **20** or output device **27**. In a typical light-emitting diode, for example, not all of the semiconductor material in the light-emitting diode necessarily emits light. Therefore, in other embodiments, the output devices **27** occupy less than one quarter of the system substrate area.

[0132] In some embodiments of the present invention, the output devices **27** are micro-light-emitting diodes (micro-LEDs), for example having light-emissive areas of less than 10, 20, 50, or 100 square microns. In other embodiments, the light emitters have physical dimensions that are less than 100  $\mu\text{m}$ , for example having a width from 2 to 5  $\mu\text{m}$ , 5 to 10  $\mu\text{m}$ , 10 to 20  $\mu\text{m}$ , or 20 to 50  $\mu\text{m}$ , having a length from 2 to 5  $\mu\text{m}$ , 5 to 10  $\mu\text{m}$ , 10 to 20  $\mu\text{m}$ , or 20 to 50  $\mu\text{m}$ , or having a height from 2 to 5  $\mu\text{m}$ , 4 to 10  $\mu\text{m}$ , 10 to 20  $\mu\text{m}$ , or 20 to 50  $\mu\text{m}$ . The light emitters can have a size of one square micron to 500 square microns. Such micro-LEDs have the advantage of a small light-emissive area compared to their brightness as well as color purity providing highly saturated display colors and a substantially Lambertian emission providing a wide viewing angle.

[0133] According to various embodiments, the digital-drive distributed pulse-width modulation system **10**, for example as used in a digital display of the present invention, includes a variety of designs having a variety of resolutions, light emitter sizes, and displays having a range of display substrate areas. For example, display substrate areas ranging from 1 cm by 1 cm to 10 m by 10 m in size are contemplated. In general, larger light emitters are most useful, but are not limited to, larger display substrate areas. The resolution of light emitters over a display substrate can also vary, for example from 50 light emitters per inch to hundreds of light emitters per inch, or even thousands of light emitters per inch. For example, a three-color display can have one thousand 10  $\mu\text{m}$ ×10  $\mu\text{m}$  light emitters per inch (i.e., on a 25-micron pitch). For example, an approximately one-inch 128-by-128 pixel display having 3.5 micron by 10-micron emitters, suitable for modification to form a pulse-width modulation system as described herein, has been constructed and successfully operated as described in U.S. patent application Ser. No. 14/743,981, filed Jun. 18, 2015, entitled Micro Assembled Micro LED Displays and Lighting Elements. Thus, the present invention has application in both low-resolution and very high-resolution displays.

[0134] As shown in FIG. 1, the elements **20** form a regular array on the system substrate **82**. Alternatively, at least some of the elements **20** have an irregular arrangement on the system substrate **82**.

[0135] In some embodiments, the chiplets **21** are formed in substrates or on supports separate from the system substrate **82**. For example, the output devices **27** are separately formed in a semiconductor wafer. The output devices **27** are then removed from the wafer and transferred, for example using micro transfer printing, to the system substrate **82** or module substrate. This arrangement has the advantage of using a crystalline semiconductor substrate that provides higher-performance integrated circuit components than can be made in the amorphous or polysilicon semiconductor available on a large substrate such as the system substrate **82**.

[0136] By employing a multi-step transfer or assembly process, increased yields are achieved and thus reduced costs for the digital-drive distributed pulse-width modulation

system **10** of the present invention. Additional details useful in understanding and performing aspects of the present invention are described in U.S. patent application Ser. No. 14/743,981, filed Jun. 18, 2015, entitled Micro Assembled Micro LED Displays and Lighting Elements.

[0137] As is understood by those skilled in the art, the terms “over”, “under”, “above”, “below”, “beneath”, and “on” are relative terms and can be interchanged in reference to different orientations of the layers, elements, and substrates included in the present invention. For example, a first layer on a second layer, in some embodiments means a first layer directly on and in contact with a second layer. In other embodiments, a first layer on a second layer can include another layer there between.

[0138] Having described certain embodiments, it will now become apparent to one of skill in the art that other embodiments incorporating the concepts of the disclosure may be used. Therefore, the invention should not be limited to the described embodiments, but rather should be limited only by the spirit and scope of the following claims.

[0139] Throughout the description, where apparatus and systems are described as having, including, or comprising specific components, or where processes and methods are described as having, including, or comprising specific steps, it is contemplated that, additionally, there are apparatus, and systems of the disclosed technology that consist essentially of, or consist of, the recited components, and that there are processes and methods according to the disclosed technology that consist essentially of, or consist of, the recited processing steps.

[0140] It should be understood that the order of steps or order for performing certain action is immaterial so long as the disclosed technology remains operable. Moreover, two or more steps or actions in some circumstances can be conducted simultaneously. The invention has been described in detail with particular reference to certain embodiments thereof, but it will be understood that variations and modifications can be effected within the spirit and scope of the invention.

#### PARTS LIST

- [0141] B0 multi-bit digital value bit 0
- [0142] B1 multi-bit digital value bit 1
- [0143] B2 multi-bit digital value bit 2
- [0144] B3 multi-bit digital value bit 3
- [0145] B4 multi-bit digital value bit 4
- [0146] B5 multi-bit digital value bit 5
- [0147] B6 multi-bit digital value bit 6
- [0148] B7 multi-bit digital value bit 7
- [0149] B8 multi-bit digital value bit 8
- [0150] B9 multi-bit digital value bit 9
- [0151] C0 counter output bit 0
- [0152] C1 counter output bit 1
- [0153] C2 counter output bit 2
- [0154] C3 counter output bit 3
- [0155] C4 counter output bit 4
- [0156] C5 counter output bit 5
- [0157] C6 counter output bit 6
- [0158] C7 counter output bit 7
- [0159] C8 counter output bit 8
- [0160] C9 counter output bit 9
- [0161] 10 pulse-width modulation system
- [0162] 12 array
- [0163] 20 pulse-width modulation element



[0164] 21 chiplet  
 [0165] 22 counter/down counter/PWM counter  
 [0166] 23 up counter  
 [0167] 24 OR logic circuit  
 [0168] 25 enable signal  
 [0169] 26 drive circuit  
 [0170] 27 output device  
 [0171] 28 digital memory/serial shift register  
 [0172] 29 logic circuit  
 [0173] 30 serial input  
 [0174] 32 clock signal/PWM clock  
 [0175] 34 delay circuit  
 [0176] 40 system controller  
 [0177] 42 memory  
 [0178] 44 communication circuit  
 [0179] 46 timing circuit  
 [0180] 50 light emitter  
 [0181] 50R red light emitter  
 [0182] 50G green light emitter  
 [0183] 50B blue light emitter  
 [0184] 60 bus  
 [0185] 70 full-color pixel  
 [0186] 82 system substrate  
 [0187] 84 row lines  
 [0188] 96 column lines  
 [0189] 90 comparator circuit/parallel comparator  
 [0190] 91 serial comparator  
 [0191] 92 output state flip-flop  
 [0192] 94 serial state flip-flop  
 [0193] 98 cycle counter  
 [0194] 100 provide pixel values step  
 [0195] 102 provide full-bit digital values step  
 [0196] 105 set multi-bit count and rate to 0 step  
 [0197] 110 load pixel values step  
 [0198] 115 load multi-bit pixel value step  
 [0199] 120 set counter=pixel value step  
 [0200] 130 test counter=0 step  
 [0201] 140 decrement counter step  
 [0202] 145 test multi-bit count done step  
 [0203] 150 enable output step  
 [0204] 155 increment multi-bit count and rate step  
 [0205] 160 test cycle done step  
 [0206] 170 test frame done step  
 [0207] 200 load multi-bit digital values step  
 [0208] 210 set cycle counter step  
 [0209] 220 set PWM counter step  
 [0210] 230 turn output device off step  
 [0211] 240 enable PWM counter step  
 [0212] 250 compare count output to multi-bit digital values step  
 [0213] 251 reset bit compare state step  
 [0214] 252 set bit counter step  
 [0215] 253 enable bit counter step  
 [0216] 254 compare PWM count output bit to multi-bit digital bit step  
 [0217] 255 match step  
 [0218] 256 set bit compare state step  
 [0219] 257 decrement bit counter step  
 [0220] 258 test bit count=0 step  
 [0221] 260 match step  
 [0222] 270 turn output device on step  
 [0223] 280 decrement PWM counter step

[0224] 290 test PWM count=0 step  
 [0225] 300 decrement cycle counter step  
 [0226] 310 test cycle count=0 step

What is claimed:

1. A distributed pulse-width modulation system, comprising:

an array of pulse-width modulation elements, wherein each element of the array comprises:

a digital memory for storing a plurality of multi-bit digital values, the multi-bit digital values all having the same number of bits,

a drive circuit for each stored multi-bit digital value, and

an output device for each stored multi-bit digital value, wherein, for each stored multi-bit digital value, the corresponding drive circuit drives the corresponding output device in response to the multi-bit digital value stored in the digital memory; and

a system controller including a memory for storing the plurality of multi-bit digital values for each pulse-width modulation element and a communication circuit for communicating each multi-bit digital value to each corresponding pulse-width modulation element.

2. The system of claim 1, wherein the system controller includes a timing circuit for providing timing signals to each element and wherein the timing signals control the rate at which the output devices are driven in response to the multi-bit digital values stored in the digital memory.

3. The system of claim 1, wherein each element of the array comprises a PWM counter with a counter output having as many bits as the number of bits in the multi-bit digital values and a comparator circuit for each stored multi-bit digital value, wherein each comparator circuit compares the counter output to the corresponding multi-bit digital value, and wherein each drive circuit is responsive to the output of the corresponding comparator circuit.

4. The system of claim 3, wherein the comparator circuit is a parallel comparator circuit.

5. The system of claim 3, wherein the comparator circuit is a serial comparator circuit.

6. The system of claim 3, wherein the drive circuit comprises an output state indicating whether the output is off or on and the drive circuit drives the output device to output a signal when the output state is on and drives the output device such that the output device does not output a signal when the output state is off.

7. The system of claim 6, wherein the drive circuit drives the output device to output a signal in a constant state over time when the output state is on.

8. The system of claim 7, wherein the signal is an electrical signal and the constant state comprises at least one of a constant current and a constant voltage.

9. The system of claim 3, comprising a cycle counter, wherein:

the cycle counter is separate from the PWM counter or the cycle counter and the PWM counter are part of a common counter, and

the PWM counter operates with the cycle counter to provide multiple cycles of PWM timing signals for the multi-bit digital values.

10. The system of claim 9, wherein the drive circuit comprises an output state indicating whether the output is off



or on and wherein the drive circuit comprises circuitry to set the output state to the off state when the lower counter bits are equal to zero.

11. The system of claim 3, wherein the comparator circuit comprises an exclusive NOR combination of at least a portion of the bits of the counter value and the bits of the corresponding multi-bit digital value.

12. The system of claim 1, wherein the digital memory is a register, a random access memory, or a content addressable memory.

13. The system of claim 1, wherein the output device is a light emitter, a light-emitting diode, an inorganic light-emitting diode, or a micro-light-emitting diode.

14. A method of operating a distributed pulse-width modulation system, wherein the distributed pulse-width modulation system comprises

an array of pulse-width modulation elements, wherein each element comprises a digital memory for storing a plurality of multi-bit digital values, the multi-bit digital values all having the same number of bits, a drive circuit for each stored multi-bit digital value, and an output device for each stored multi-bit digital value, wherein, for each stored multi-bit digital value, the corresponding drive circuit drives the corresponding output device in response to the multi-bit digital value stored in the digital memory; and

a system controller including a memory for storing the plurality of multi-bit digital values for each pulse-width modulation element and a communication circuit for communicating each multi-bit digital value to each corresponding pulse-width modulation element, and the method comprises:

loading the multi-bit digital values into the digital memory of each element of the array; and driving each output device in response to the corresponding multi-bit digital value.

15. A method of operating a distributed pulse-width modulation system, wherein the distributed pulse-width modulation system comprises

an array of pulse-width modulation elements, wherein each element comprises a digital memory for storing a plurality of multi-bit digital values, the multi-bit digital values all having the same number of bits, a drive circuit for each stored multi-bit digital value, and an output device for each stored multi-bit digital value, wherein, for each stored multi-bit digital value, the corresponding drive circuit drives the corresponding output device in response to the multi-bit digital value stored in the digital memory; and

a system controller including a memory for storing the plurality of multi-bit digital values for each pulse-width modulation element and a communication circuit for communicating each multi-bit digital value to each corresponding pulse-width modulation element, wherein

each element of the array comprises a PWM counter with a PWM counter output having as many bits as the number of bits in the multi-bit digital values and a comparator circuit for each stored multi-bit digital value, wherein each comparator circuit compares the counter output to the corresponding multi-bit digital

value, and wherein each drive circuit is responsive to the output of the corresponding comparator circuit, and the method comprises:

loading the multi-bit digital values into each element of the array;

setting the PWM counter to an initial count value; and repeatedly operating the PWM counter to count and comparing the PWM counter output to each multi-bit digital value with the comparator circuit and, if the PWM counter output matches the multi-bit digital value, driving each output device with the drive circuit to output a signal or to stop outputting a signal.

16. The method of claim 15, wherein each element in the array comprises a cycle counter and the method comprises restarting the PWM counter each time the cycle counter counts and restarting the cycle counter responsive to the communication circuit.

17. The method of claim 15, wherein the drive circuit comprises an output state indicating whether the output is off or on, and the method comprises:

setting the output state to the off state responsive to the PWM counter output equaling zero or starting a count cycle; or

setting the output state to the on state responsive to the PWM counter output equaling zero or starting a count cycle.

18. The method of claim 15, wherein the drive circuit comprises an output state indicating whether the output is off or on, and the method comprises:

setting the output state to the on state responsive to the PWM counter bits equaling the stored multi-bit digital value; or

setting the output state to the off state responsive to the PWM counter bits equaling the stored multi-bit digital value.

19. The method of claim 16, wherein each comparator circuit is a parallel comparator circuit and each digital memory comprises registers having parallel register outputs, and the method comprises:

simultaneously comparing each bit of a multi-bit digital value in a corresponding register to a corresponding bit of the PWM counter output with a corresponding parallel comparator circuit; and

driving each output device, with the corresponding drive circuit, to output a signal in response to a match between the corresponding multi-bit digital value and the PWM counter output.

20. The method of claim 16, wherein each comparator circuit is a serial comparator circuit and the digital memory is a random access memory storing the bits of each multi-bit digital value at a common address in corresponding bit planes, and the method comprises:

sequentially comparing each bit of the multi-bit digital values to a corresponding bit of the PWM counter output with a corresponding serial comparator circuit; and

driving each output device, with the corresponding drive circuit, to output a signal in response to a match between the corresponding multi-bit digital value and the PWM counter output.

\* \* \* \* \*

专利名称(译)	多像素分布式脉宽调制控制		
公开(公告)号	<a href="#">US20170330509A1</a>	公开(公告)日	2017-11-16
申请号	US15/590827	申请日	2017-05-09
[标]申请(专利权)人(译)	艾克斯瑟乐普林特有限公司		
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发明人	COK, RONALD S. ROTZOLL, ROBERT R.		
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其他公开文献	US10360846		
外部链接	<a href="#">Espacenet</a> <a href="#">USPTO</a>		

#### 摘要(译)

分布式脉冲宽度调制系统包括脉冲宽度调制元件阵列，每个元件包括用于存储多个多位数字值的数字存储器，用于每个存储的多位数字值的驱动电路，以及输出装置对于每个存储的多位数字值。多位数字值都具有相同的位数。对于每个存储的多位数字值，相应的驱动电路响应于存储在数字存储器中的多位数字值驱动相应的输出装置。系统控制器包括用于存储每个脉冲宽度调制元件的多位数字值的存储器，并且通信电路将每个多位数字值传送到每个相应的脉冲宽度调制元件。

